10-FY07BVA030RW-LF42E28
datasheet

Vincotech

***flow*SOL 1 BI (TL)** | **650 V / 30 A**

Topology features

- Kelvin Emitter for improved switching performance
- Temperature sensor
- Booster + H6.5

Component features

- High efficiency in hard switching and resonant topologies
- High speed switching
- Low gate charge

Housing features

- Base isolation: Al_2O_3
- Convex shaped substrate for superior thermal contact
- Thermo-mechanical push-and-pull force relief
- Solder pin

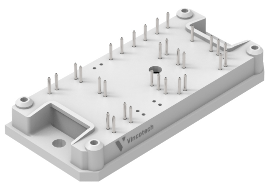
Target applications

- Solar Inverters

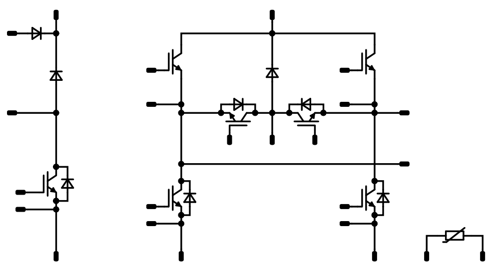
Types

- 10-FY07BVA030RW-LF42E28

flow 1 12 mm housing



Schematic



Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
Low Buck Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	36	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		120	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	63	W
Gate-emitter voltage	V_{GES}			±30	V
Maximum junction temperature	T_{jmax}			175	°C
High Buck Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	36	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		120	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	63	W
Gate-emitter voltage	V_{GES}			±30	V
Maximum junction temperature	T_{jmax}			175	°C
Buck Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	29	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		40	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	51	W
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	28	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		60	A
Turn off safe operating area		T_j = 150°C, V_{CE} = 1200 V		60	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	59	W
Gate-emitter voltage	V_{GES}			±20	V
Short circuit ratings	t_{SC}	V_{GE} = 15 V, V_{CC} = 360 V	T_j = 150 °C	6	µs
Maximum junction temperature	T_{jmax}			175	°C
Low Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	29	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		40	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	51	W
Maximum junction temperature	T_{jmax}			175	°C
High Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	29	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		40	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	51	W
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
Input Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$	T_s = 80 °C	36	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		120	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	63	W
Gate-emitter voltage	V_{GES}			±30	V
Maximum junction temperature	T_{jmax}			175	°C
Input Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	34	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		60	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	50	W
Maximum junction temperature	T_{jmax}			175	°C
Input Boost Sw. Protection Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	17	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		20	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	33	W
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value	Unit
ByPass Diode					
Peak repetitive reverse voltage	V_{RRM}			1600	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$	T_s = 80 °C	46	A
Surge (non-repetitive) forward current	I_{FSM}	Single Half Sine Wave, t_p = 10 ms	T_j = 150 °C	270	A
Surge current capability	I^2t			370	A^2s
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	56	W
Maximum junction temperature	T_{jmax}			150	°C
Module Properties					
Thermal Properties					
Storage temperature	T_{stg}			-40…+125	°C
Operation temperature under switching condition	T_{jop}			-40…+(T_{jmax} - 25)	°C
Isolation Properties					
Isolation voltage	V_{isol}	DC Test Voltage*	t_p = 2 s	6000	V
Isolation voltage	V_{isol}	AC Voltage	t_p = 1 min	2500	V
Creepage distance				>12,7	mm
Clearance				8,16	mm
Comparative Tracking Index	CTI			≥ 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Values Min	Typ	Max	Unit
Low Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$			5	0,02	25	5	6	7	V
Collector-emitter saturation voltage	V_{CEsat}		15		30	25 125 150		1,44 1,61 1,64	1,9(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			0,01	mA
Gate-emitter leakage current	I_{GES}		30	0		25			0,2	µA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	30		25		2530		pF
Output capacitance	C_{oes}							65		pF
Reverse transfer capacitance	C_{res}							46		pF
Gate charge	Q_g		15	400	30	25		84		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,5		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 8 Ω R_{goff} = 8 Ω	±15	350	30	25 125 150		42 43 43		ns
Rise time	t_r					25 125 150		7 7 7		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		59 67 68		ns
Fall time	t_f					25 125 150		21,64 36,5 52,33		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=2,03 µC Q_{rFWD}=2,74 µC Q_{rFWD}=2,99 µC				25 125 150		0,374 0,471 0,495		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,256 0,387 0,441		mWs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Values Min	Typ	Max	Unit
High Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$			5	0,02	25	5	6	7	V
Collector-emitter saturation voltage	V_{CEsat}		15		30	25 125 150		1,44 1,61 1,64	1,9(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			0,01	mA
Gate-emitter leakage current	I_{GES}		30	0		25			0,2	μA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	30		25		2530		pF
Output capacitance	C_{oes}							65		pF
Reverse transfer capacitance	C_{res}							46		pF
Gate charge	Q_g		15	400	30	25		84		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,5		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 8 Ω R_{goff} = 8 Ω	±15	350	30	25 125 150		42 43 43		ns
Rise time	t_r					25 125 150		7 7 7		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		59 67 68		ns
Fall time	t_f					25 125 150		21,64 36,5 52,33		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=2,03 μC Q_{rFWD}=2,74 μC Q_{rFWD}=2,99 μC				25 125 150		0,374 0,471 0,495		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,256 0,387 0,441		mWs

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Buck Diode										
Static										
Forward voltage	V_F				20	25 125 150		1,56 1,51 1,51	1,92(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			1,28	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,88		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt=6385 A/µs di/dt=6312 A/µs di/dt=6023 A/µs	±15	350	30	25 125 150		69,9 76,16 78,25		A
Reverse recovery time	t_{rr}					25 125 150		50,69 90,9 93,49		ns
Recovered charge	Q_r					25 125 150		2,03 2,74 2,99		µC
Reverse recovered energy	E_{rec}					25 125 150		0,532 0,69 0,751		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		5003 5228 5263		A/µs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Values Min	Typ	Max	Unit
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$			0,00029	25	5,1	5,8	6,4	V
Collector-emitter saturation voltage	V_{CEsat}		15		20	25 125 150	1,03	1,5 1,68 1,71	1,87(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			1	µA
Gate-emitter leakage current	I_{GES}		20	0		25			150	nA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	25		25		1100		pF
Output capacitance	C_{oes}							71		pF
Reverse transfer capacitance	C_{res}							32		pF
Gate charge	Q_g	V_{CC} = 480 V	15		20	25		120		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,6		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 16 Ω R_{goff} = 16 Ω	±15	350	20	25 125 150		62 61 61		ns
Rise time	t_r					25 125 150		22 21 20		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		131 150 154		ns
Fall time	t_f					25 125 150		72,1 105,2 114,85		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=0,614 µC Q_{rFWD}=1,2 µC Q_{rFWD}=1,38 µC				25 125 150		0,524 0,705 0,765		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,431 0,607 0,643		mWs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Low Boost Diode										
Static										
Forward voltage	V_F				20	25 125 150		1,56 1,51 1,51	1,92(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			1,28	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,88		K/W
Dynamic										
Peak recovery current	I_{RRM}	d*i*/d*t*=3350 A/µs d*i*/d*t*=868 A/µs d*i*/d*t*=1011 A/µs	±15	350	20	25 125 150		12,81 17,01 17,57		A
Reverse recovery time	t_{rr}					25 125 150		71,53 113,68 126,68		ns
Recovered charge	Q_r					25 125 150		0,614 1,2 1,38		µC
Reverse recovered energy	E_{rec}					25 125 150		0,093 0,197 0,234		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		220,72 183,67 146,55		A/µs

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
High Boost Diode										
Static										
Forward voltage	V_F				20	25 125 150		1,56 1,51 1,51	1,92(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			1,28	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,88		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt=3350 A/µs di/dt=868 A/µs di/dt=1011 A/µs	±15	350	20	25 125 150		12,81 17,01 17,57		A
Reverse recovery time	t_{rr}					25 125 150		71,53 113,68 126,68		ns
Recovered charge	Q_r					25 125 150		0,614 1,2 1,38		µC
Reverse recovered energy	E_{rec}					25 125 150		0,093 0,197 0,234		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		220,72 183,67 146,55		A/µs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Values Min	Typ	Max	Unit
Input Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$			5	0,02	25	5	6	7	V
Collector-emitter saturation voltage	V_{CEsat}		15		30	25 125 150		1,44 1,61 1,64	1,9(1)	V
Collector-emitter cut-off current	I_{CES}		0	650		25			0,01	mA
Gate-emitter leakage current	I_{GES}		30	0		25			0,2	µA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	30		25		2530		pF
Output capacitance	C_{oes}							65		pF
Reverse transfer capacitance	C_{res}							46		pF
Gate charge	Q_g		15	400	30	25		84		nC
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,5		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 8 Ω R_{goff} = 8 Ω	0/15	400	30	25 125 150		21 19 19		ns
Rise time	t_r					25 125 150		8 8 8		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		93 106 109		ns
Fall time	t_f					25 125 150		18,35 29,84 33,52		ns
Turn-on energy (per pulse)	E_{on}	Q_{rFWD}=1,07 µC Q_{rFWD}=1,96 µC Q_{rFWD}=2,28 µC				25 125 150		0,501 0,658 0,679		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,295 0,45 0,468		mWs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	Unit
Input Boost Diode										
Static										
Forward voltage	V_F				30	25 125 150		1,52 1,46 1,43	1,92[1]	V
Reverse leakage current	I_R	V_r = 650 V				25			1,6	µA
Thermal										
Thermal resistance junction to sink [2]	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,92		K/W
Dynamic										
Peak recovery current	I_{RRM}	d*i*/d*t*=5993 A/µs d*i*/d*t*=5650 A/µs d*i*/d*t*=5315 A/µs	0/15	400	30	25 125 150		50,22 63,43 67,68		A
Reverse recovery time	t_{rr}					25 125 150		42,3 64,99 72,95		ns
Recovered charge	Q_r					25 125 150		1,07 1,96 2,28		µC
Reverse recovered energy	E_{rec}					25 125 150		0,292 0,553 0,654		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		2522 1944 2299		A/µs

Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Input Boost Sw. Protection Diode										
Static										
Forward voltage	V_F				10	25 125	1,23	1,67 1,56	1,87(1)	V
Reverse leakage current	I_R	V_r = 650 V				25			0,14	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						2,87		K/W
ByPass Diode										
Static										
Forward voltage	V_F				13	25 125		0,988 0,899	1,21(1) 1,1(1)	V
Reverse leakage current	I_R	V_r = 1600 V				25			50	µA
Thermal										
Thermal resistance junction to sink (2)	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,25		K/W
Thermistor										
Static										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P					25		130		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %						3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %						4000		K
Vincotech Thermistor Reference									I	

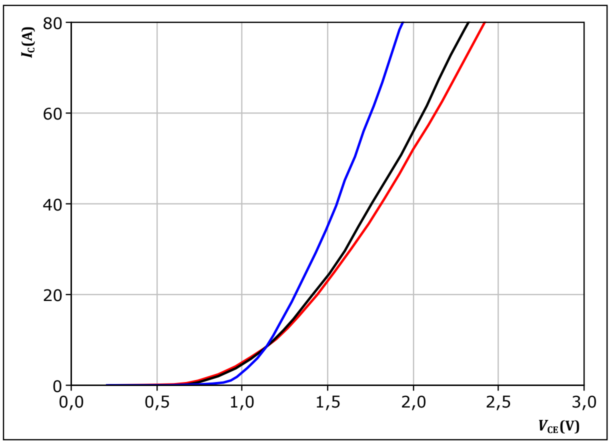
(1) Value at chip level
(2) Only valid with pre-applied Vincotech thermal interface material.

Low Buck Switch Characteristics

figure 1. IGBT

Typical output characteristics

$I_C = f(V_{CE})$

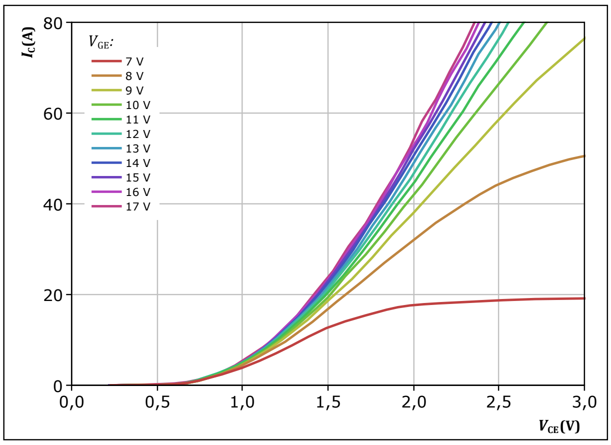


t_p = 250 µs
V_{GE} = 15 V
T_j: 25 °C, 125 °C, 150 °C

figure 2. IGBT

Typical output characteristics

$I_C = f(V_{CE})$

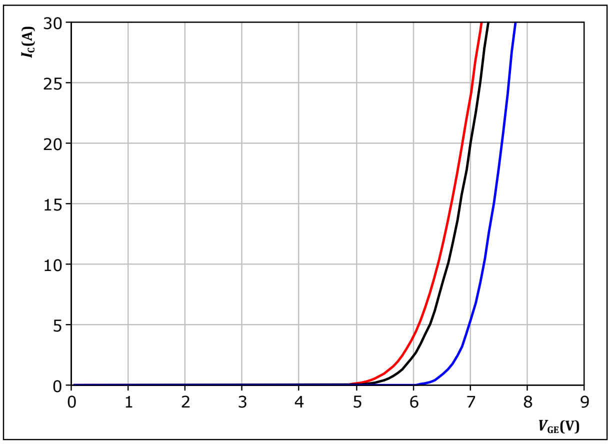


t_p = 250 µs
T_j = 150 °C
V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

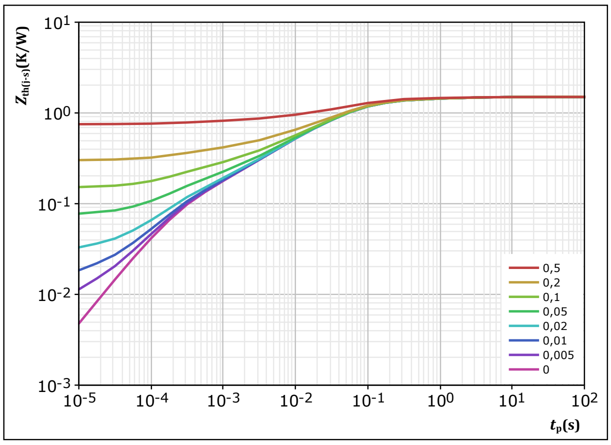


t_p = 250 µs
V_{CE} = 10 V
T_j: 25 °C, 125 °C, 150 °C

figure 4. IGBT

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



D = t_p / T
$R_{th(j-s)}$ = 1,501 K/W

IGBT thermal model values

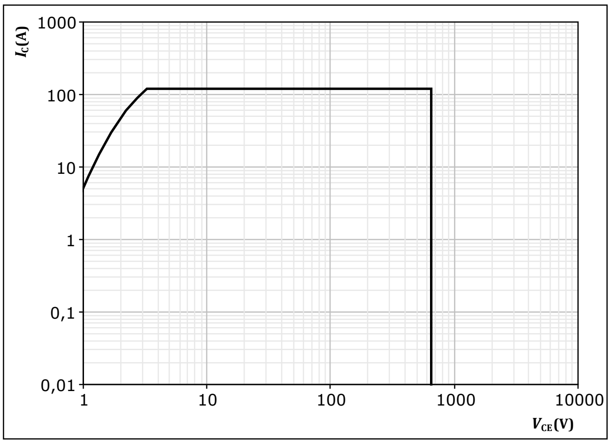
R (K/W)	τ (s)
5,92E-02	3,33E+00
1,11E-01	5,14E-01
4,91E-01	8,64E-02
4,45E-01	3,10E-02
2,28E-01	6,69E-03
7,55E-02	1,48E-03
9,11E-02	2,40E-04

Low Buck Switch Characteristics

figure 5. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



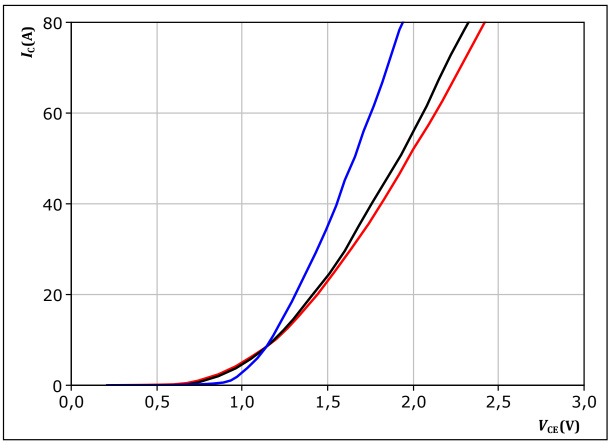
D =	single pulse	
T_s =	80	°C
V_{GE} =	15	V
T_j =	T_{jmax}	

High Buck Switch Characteristics

figure 6. IGBT

Typical output characteristics

$I_C = f(V_{CE})$



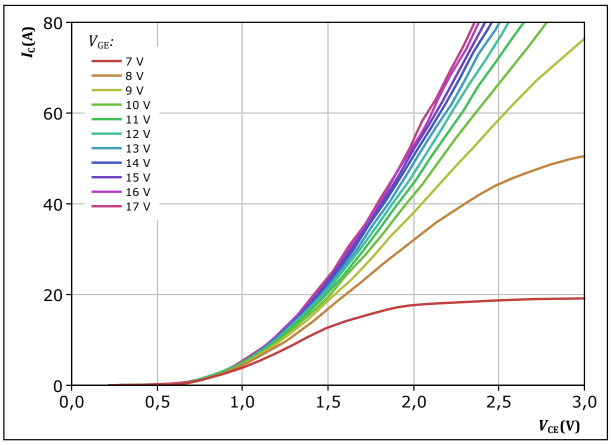
t_p =	250	µs
V_{GE} =	15	V

T_j: 25 °C, 125 °C, 150 °C

figure 7. IGBT

Typical output characteristics

$I_C = f(V_{CE})$



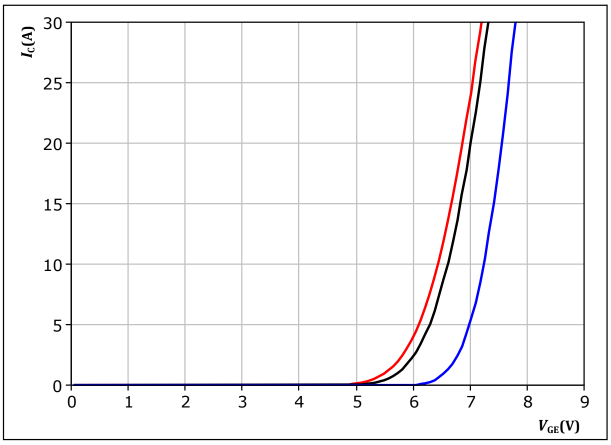
t_p =	250	µs
T_j =	150	°C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 8. IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$



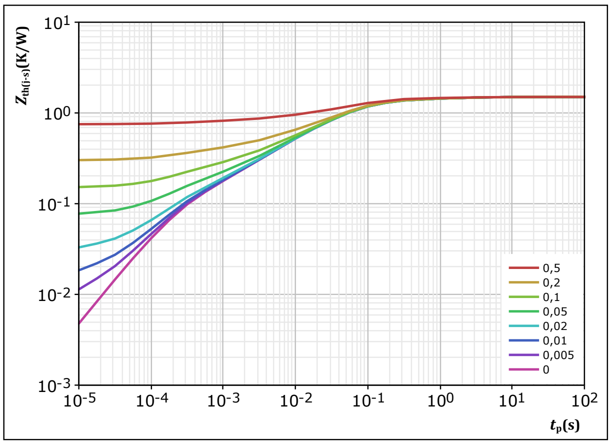
t_p =	250	µs
V_{CE} =	10	V

T_j: 25 °C, 125 °C, 150 °C

figure 9. IGBT

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



D =	t_p / T	
$R_{th(j-s)}$ =	1,501	K/W

IGBT thermal model values

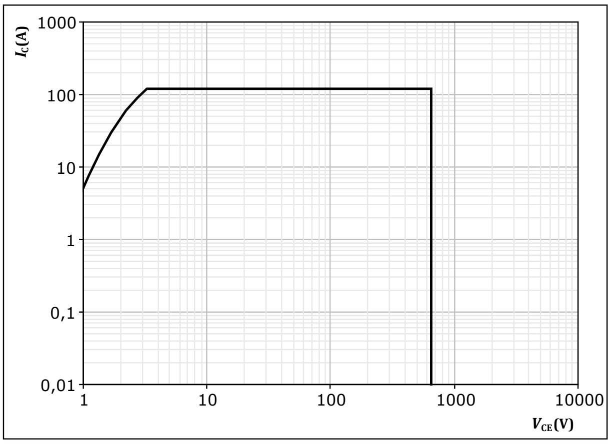
R (K/W)	τ (s)
5,92E-02	3,33E+00
1,11E-01	5,14E-01
4,91E-01	8,64E-02
4,45E-01	3,10E-02
2,28E-01	6,69E-03
7,55E-02	1,48E-03
9,11E-02	2,40E-04

High Buck Switch Characteristics

figure 10.	IGBT

Safe operating area

I_C = f(V_{CE})



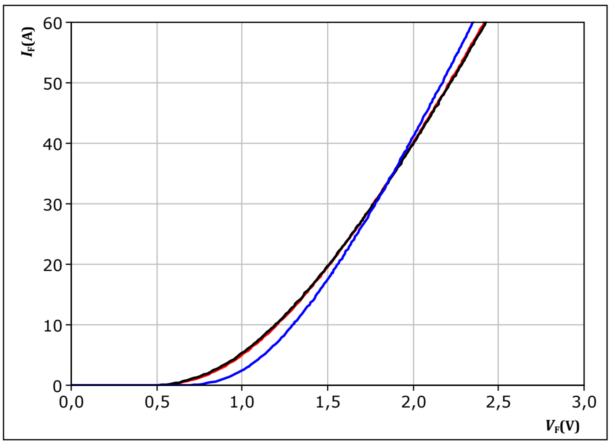
D =	single pulse	
T_s =	80	°C
V_{GE} =	15	V
T_j =	T_{jmax}	

Buck Diode Characteristics

figure 11. **FWD**

Typical forward characteristics

I_F = f(V_F)



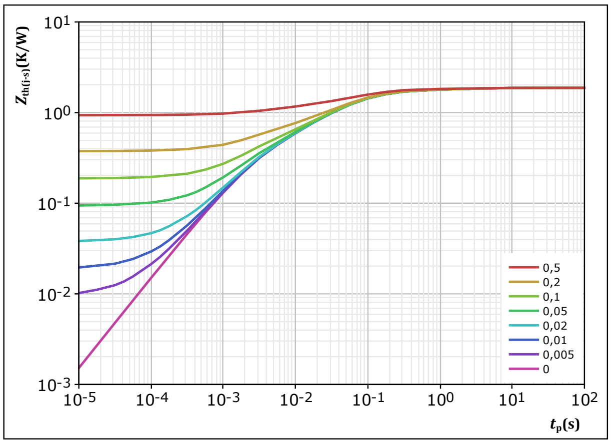
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 12. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D = t_p / T

$R_{th(j-s)}$ = 1,875 K/W

FWD thermal model values

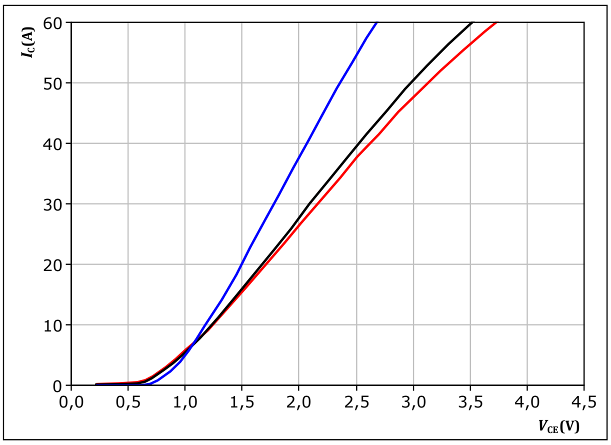
R (K/W)	τ (s)
8,42E-02	3,60E+00
1,79E-01	3,95E-01
8,86E-01	7,08E-02
4,50E-01	1,69E-02
2,75E-01	2,45E-03

Boost Switch Characteristics

figure 13. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$



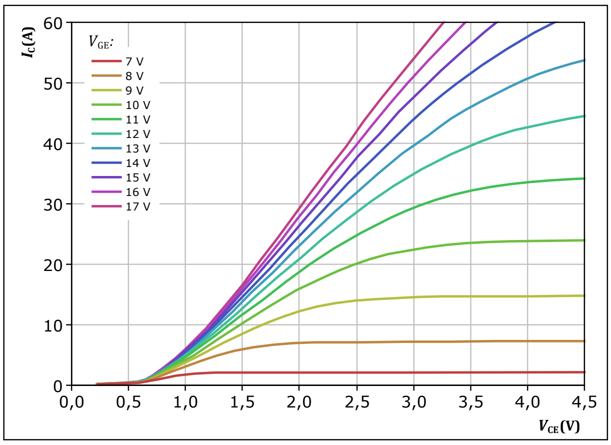
t_p =	250	μs
V_{GE} =	15	V

T_j: 25 °C, 125 °C, 150 °C

figure 14. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$



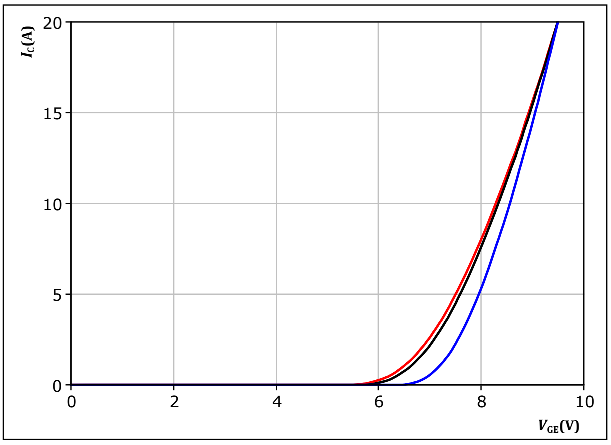
t_p =	250	μs
T_j =	150	°C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 15. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$



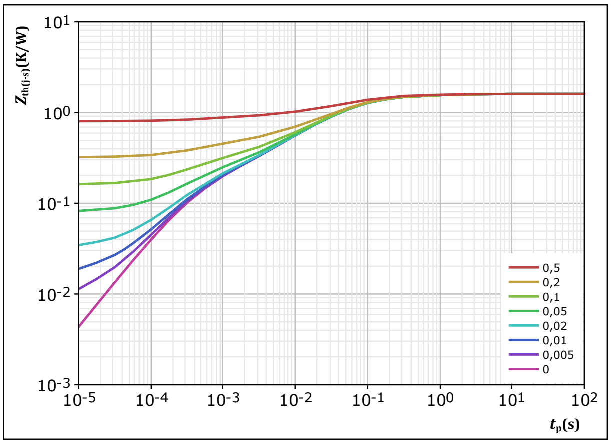
t_p =	250	μs
V_{CE} =	10	V

T_j: 25 °C, 125 °C, 150 °C

figure 16. **IGBT**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,604 K/W

IGBT thermal model values

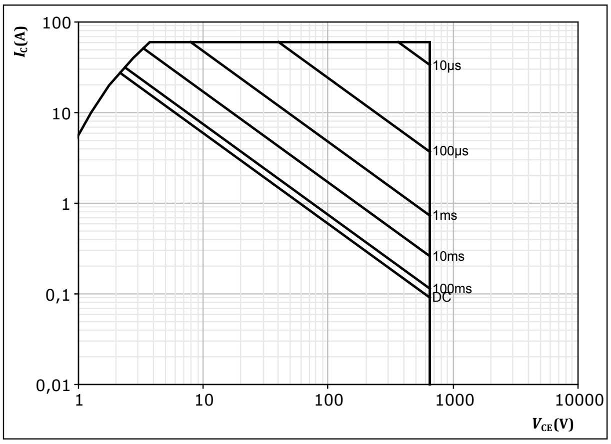
R (K/W)	τ (s)
8,72E-02	1,64E+00
2,19E-01	2,09E-01
7,41E-01	5,24E-02
3,11E-01	1,19E-02
1,15E-01	2,56E-03
1,31E-01	3,71E-04

Boost Switch Characteristics

figure 17. **IGBT**

Safe operating area

I_C = f(V_{CE})



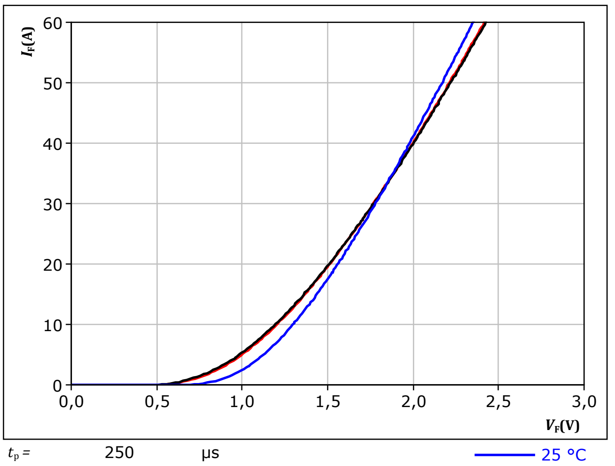
D =	single pulse	
T_s =	80	°C
V_{GE} =	15	V
T_j =	T_{jmax}	

Low Boost Diode Characteristics

figure 18. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



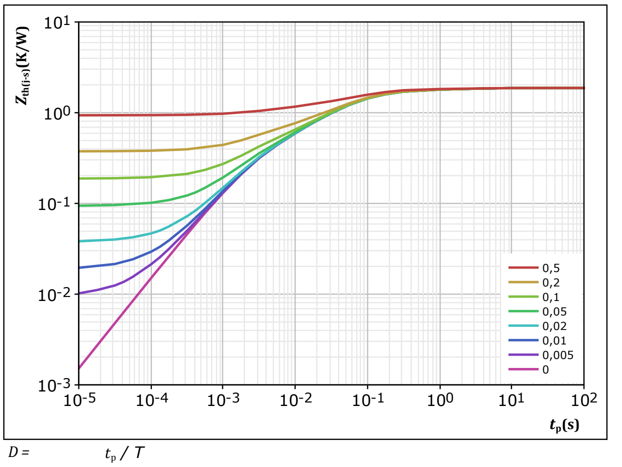
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 19. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,875 K/W

FWD thermal model values

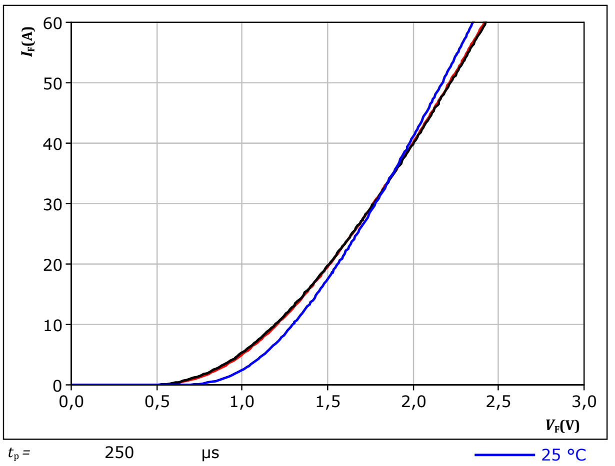
R (K/W)	τ (s)
8,42E-02	3,60E+00
1,79E-01	3,95E-01
8,86E-01	7,08E-02
4,50E-01	1,69E-02
2,75E-01	2,45E-03

High Boost Diode Characteristics

figure 20. FWD

Typical forward characteristics

$I_F = f(V_F)$



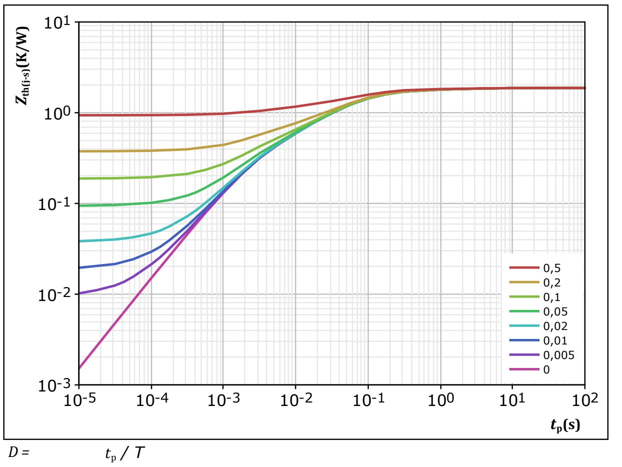
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 21. FWD

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,875 K/W

FWD thermal model values

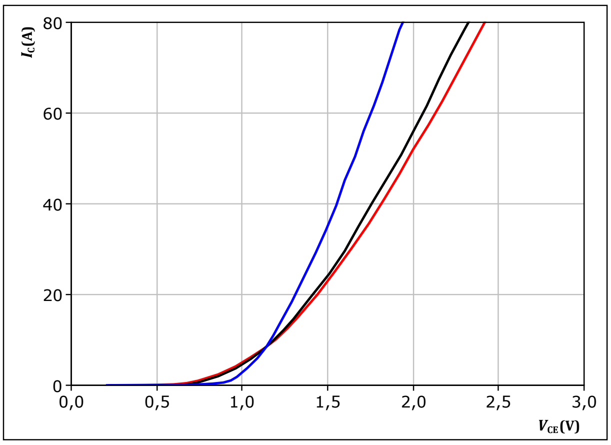
R (K/W)	τ (s)
8,42E-02	3,60E+00
1,79E-01	3,95E-01
8,86E-01	7,08E-02
4,50E-01	1,69E-02
2,75E-01	2,45E-03

Input Boost Switch Characteristics

figure 22. IGBT

Typical output characteristics

I_C = f(V_{CE})



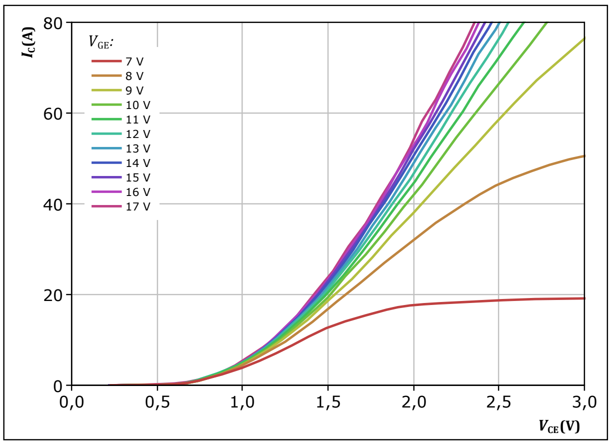
t_p =	250	µs
V_{GE} =	15	V

T_j: 25 °C, 125 °C, 150 °C

figure 23. IGBT

Typical output characteristics

I_C = f(V_{CE})



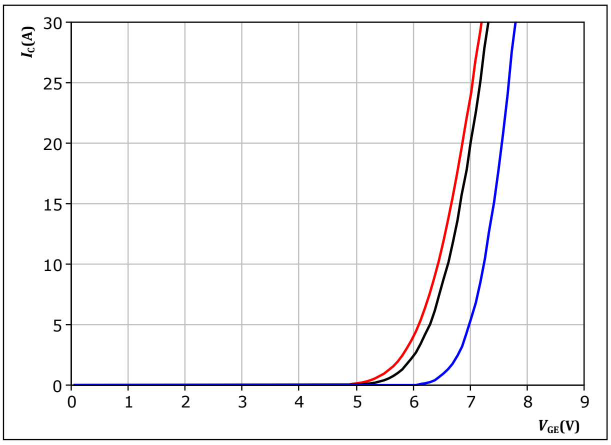
t_p =	250	µs
T_j =	150	°C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 24. IGBT

Typical transfer characteristics

I_C = f(V_{GE})



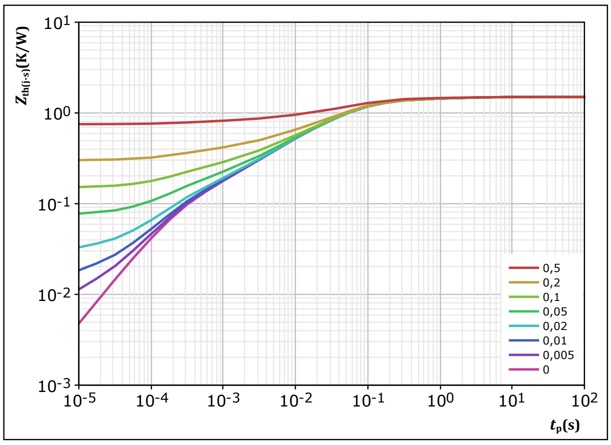
t_p =	250	µs
V_{CE} =	10	V

T_j: 25 °C, 125 °C, 150 °C

figure 25. IGBT

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D =	t_p / T	
$R_{th(j-s)}$ =	1,501	K/W

IGBT thermal model values

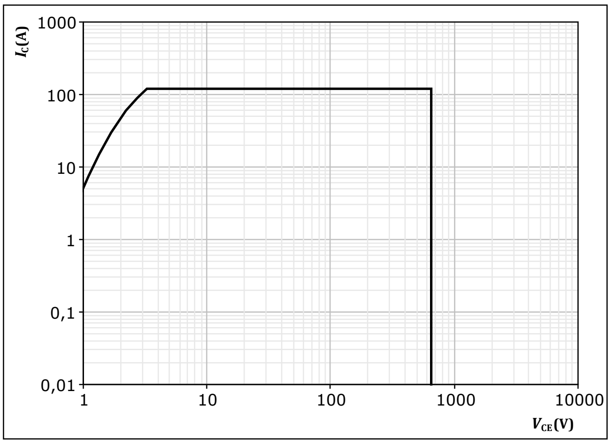
R (K/W)	τ (s)
5,92E-02	3,33E+00
1,11E-01	5,14E-01
4,91E-01	8,64E-02
4,45E-01	3,10E-02
2,28E-01	6,69E-03
7,55E-02	1,48E-03
9,11E-02	2,40E-04

Input Boost Switch Characteristics

figure 26. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



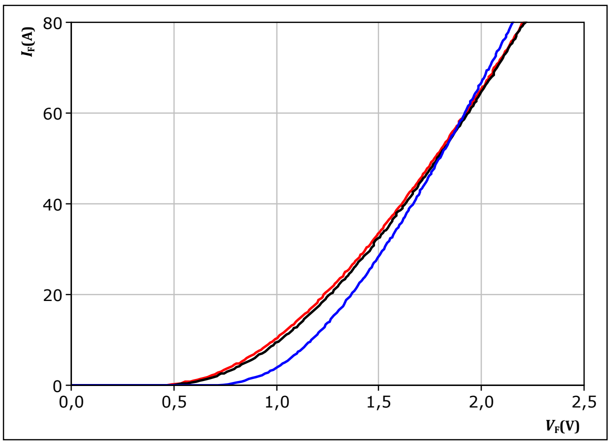
D = single pulse
T_s = 80 °C
V_{GE} = 15 V
T_j = T_{jmax}

Input Boost Diode Characteristics

figure 27. **FWD**

Typical forward characteristics

I_F = f(V_F)



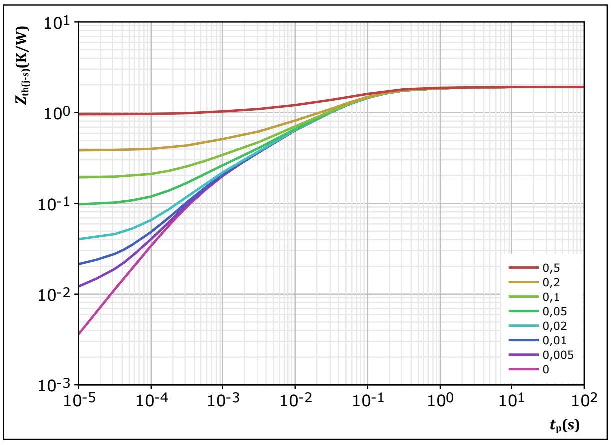
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 28. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D = t_p / T

$R_{th(j-s)}$ = 1,918 K/W

FWD thermal model values

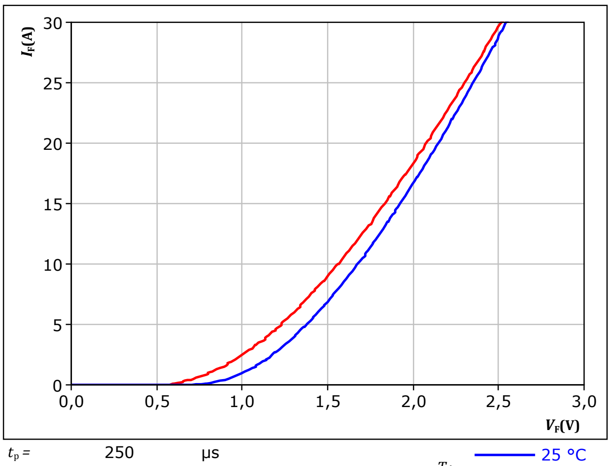
R (K/W)	τ (s)
9,41E-02	2,25E+00
3,44E-01	2,12E-01
8,56E-01	5,84E-02
3,61E-01	9,83E-03
1,37E-01	2,89E-03
1,27E-01	4,79E-04

Input Boost Sw. Protection Diode Characteristics

figure 29. **FWD**

Typical forward characteristics

I_F = f(V_F)



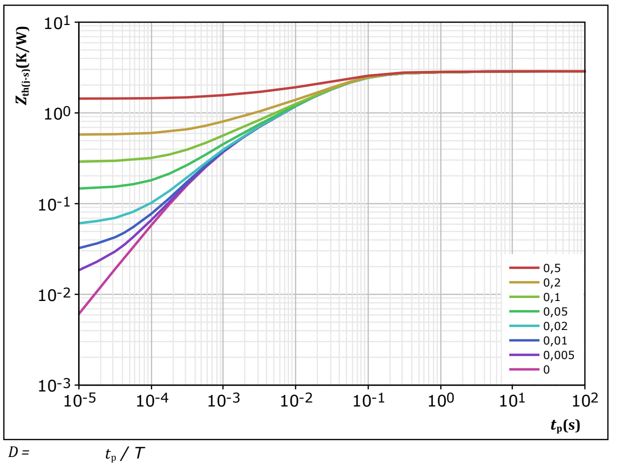
t_p = 250 µs

T_j: 25 °C, 125 °C

figure 30. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)}$ = f(t_p)



D = t_p / T

$R_{th(j-s)}$ = 2,873 K/W

FWD thermal model values

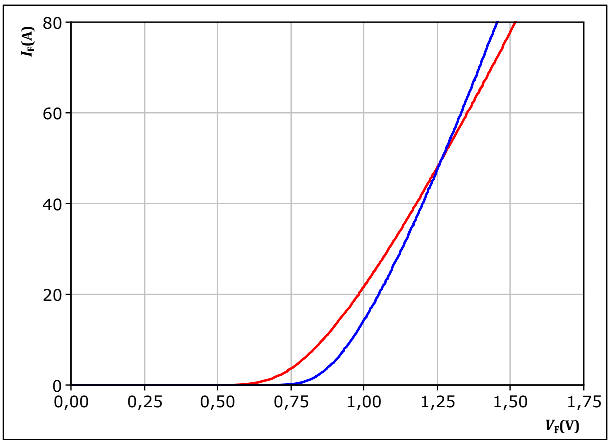
R (K/W)	τ (s)
6,53E-02	3,94E+00
1,48E-01	4,48E-01
1,31E+00	5,96E-02
7,32E-01	1,36E-02
4,04E-01	2,79E-03
2,11E-01	5,37E-04

ByPass Diode Characteristics

figure 31. **Rectifier**

Typical forward characteristics

$I_F = f(V_F)$



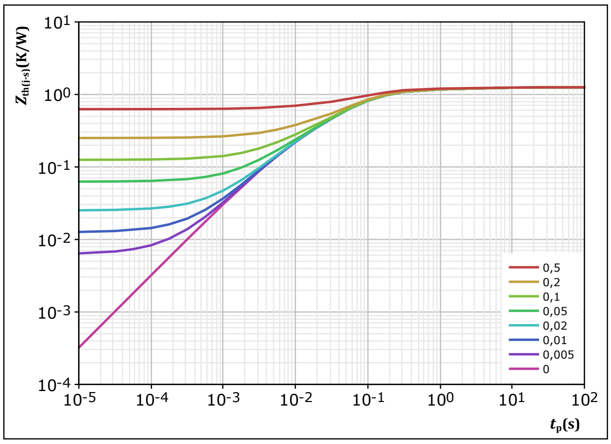
t_p = 250 µs

T_j: 25 °C, 125 °C

figure 32. **Rectifier**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,254 K/W

Rectifier thermal model values

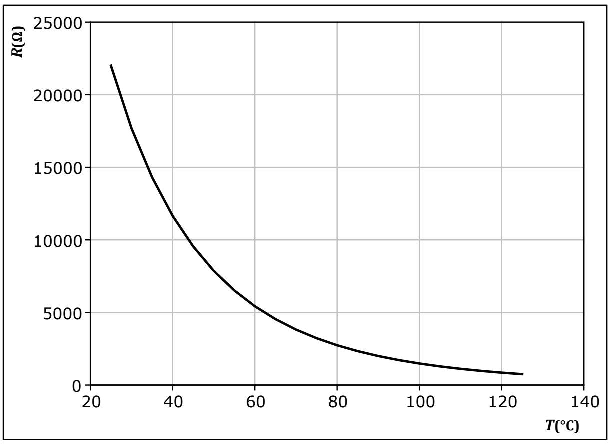
R (K/W)	τ (s)
8,00E-02	5,22E+00
1,56E-01	4,18E-01
6,95E-01	8,82E-02
2,23E-01	3,07E-02
9,97E-02	5,99E-03

Thermistor Characteristics

figure 33.	Thermistor

Typical NTC characteristic as function of temperature

R_T = f(T)

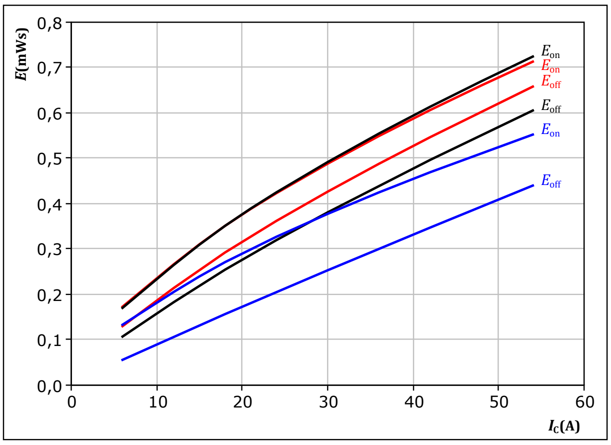


Low Buck Switching Characteristics

figure 34. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



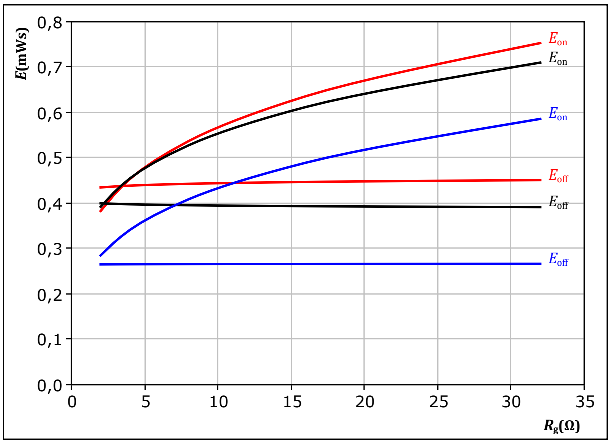
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C
R_{goff} =	8	Ω		

figure 35. **IGBT**

Typical switching energy losses as a function of IGBT turn on gate resistor

$E = f(R_g)$



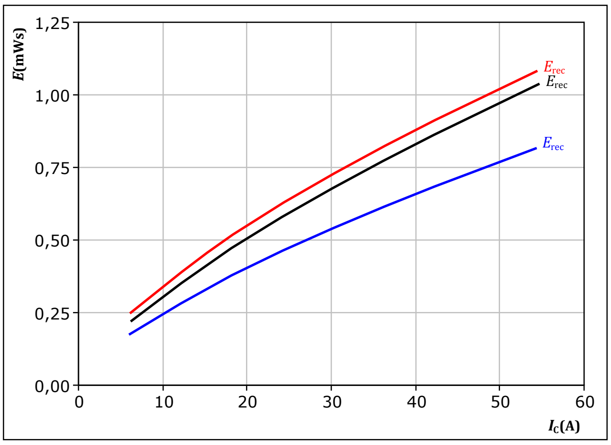
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

figure 36. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



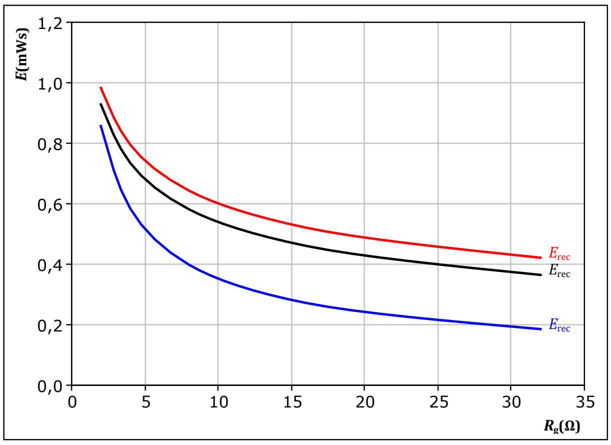
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 37. **FWD**

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

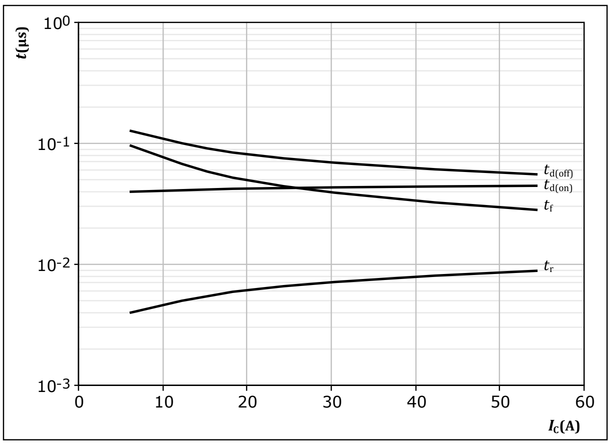
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

Low Buck Switching Characteristics

figure 38. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



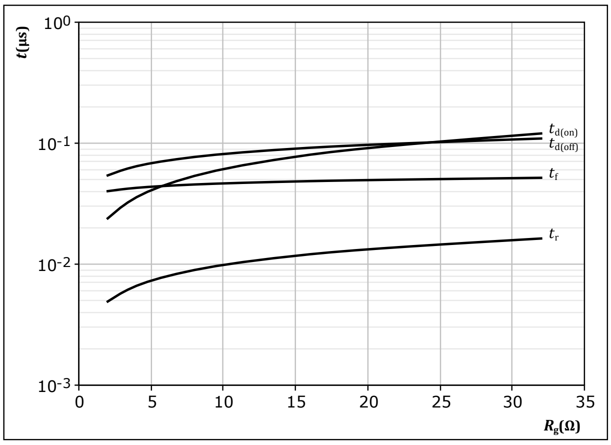
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	8	Ω
R_{goff} =	8	Ω

figure 39. **IGBT**

Typical switching times as a function of IGBT turn on gate resistor

$t = f(R_g)$



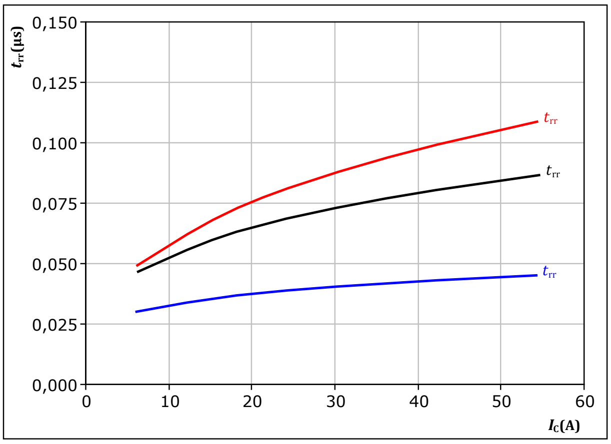
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	30	A

figure 40. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



With an inductive load at

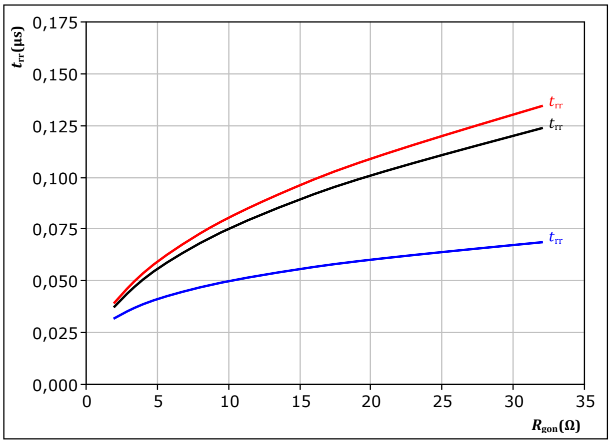
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	8	Ω

T_j: 25 °C, 125 °C, 150 °C

figure 41. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



With an inductive load at

V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	30	A

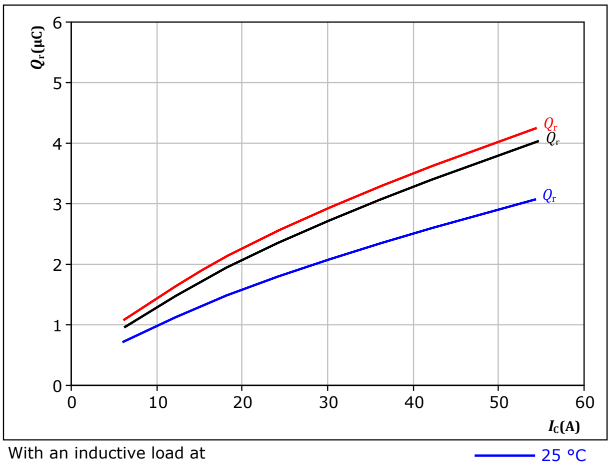
T_j: 25 °C, 125 °C, 150 °C

Low Buck Switching Characteristics

figure 42. **FWD**

Typical recovered charge as a function of collector current

Q_r = f(I_C)



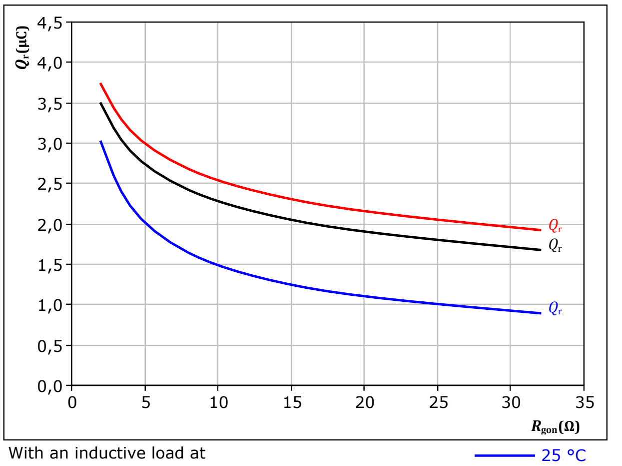
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 43. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

Q_r = f(R_{gon})



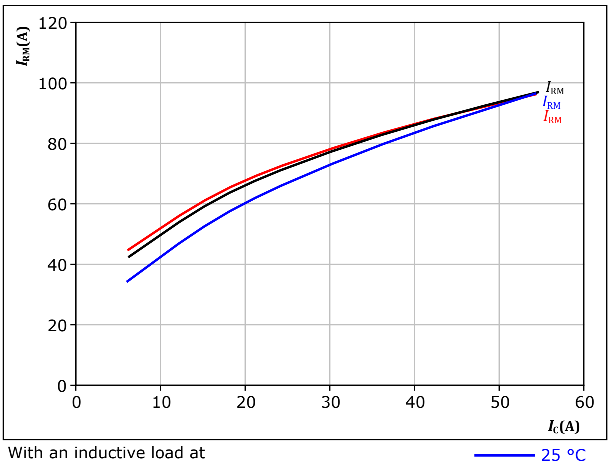
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

figure 44. **FWD**

Typical peak reverse recovery current as a function of collector current

I_{RM} = f(I_C)



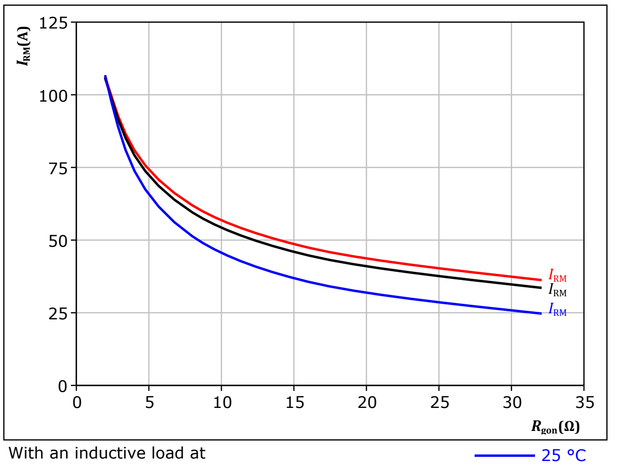
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 45. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

I_{RM} = f(R_{gon})



With an inductive load at

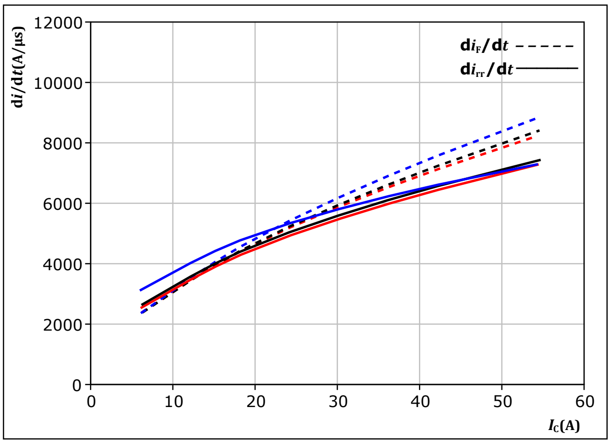
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

Low Buck Switching Characteristics

figure 46. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



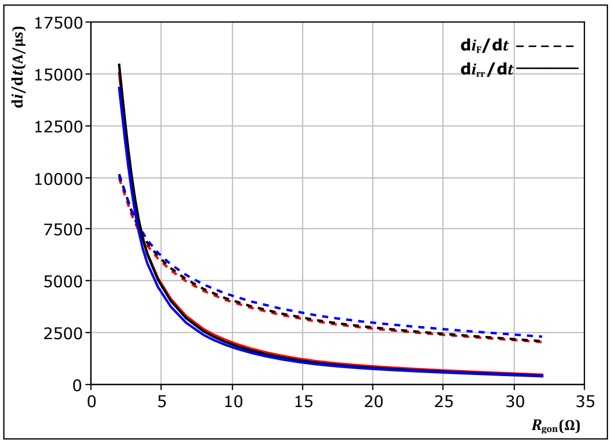
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 47. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



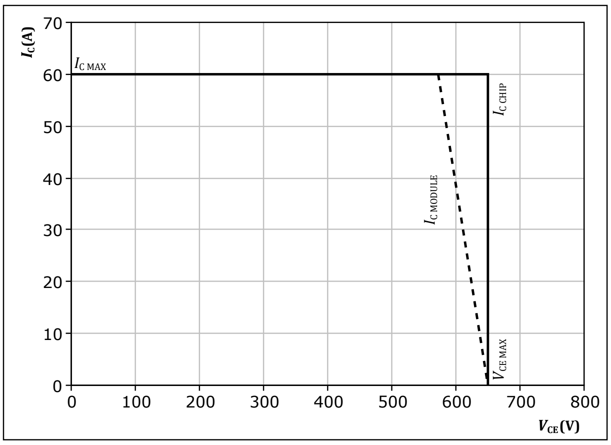
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

figure 48. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



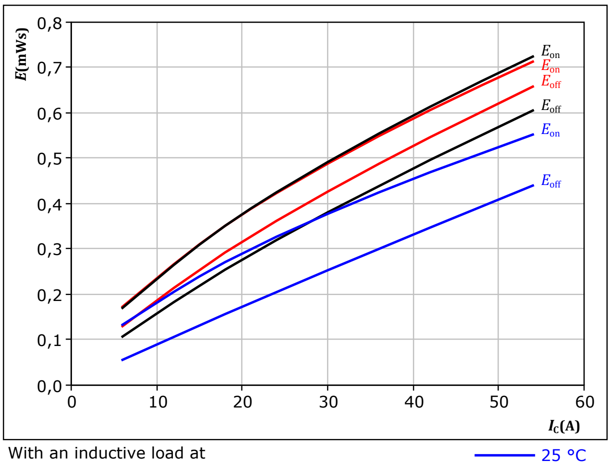
At	T_j =	150	°C
	R_{gon} =	8	Ω
	R_{goff} =	8	Ω

High Buck Switching Characteristics

figure 49. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



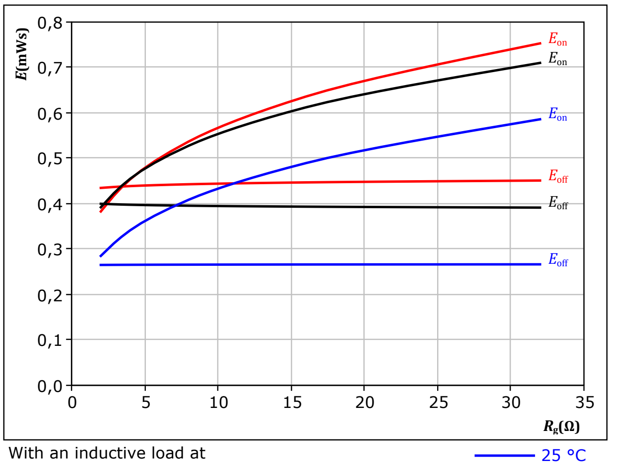
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C
R_{goff} =	8	Ω		

figure 50. **IGBT**

Typical switching energy losses as a function of IGBT turn on gate resistor

$E = f(R_g)$



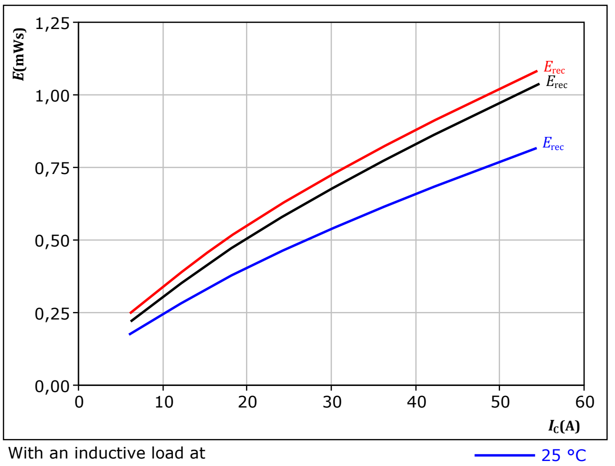
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

figure 51. **IGBT**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



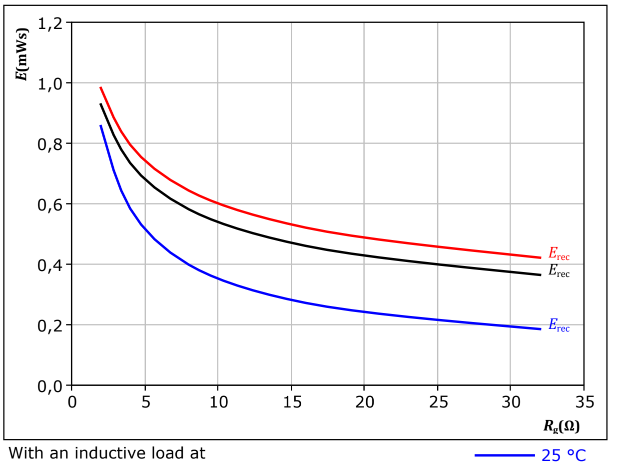
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 52. **IGBT**

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

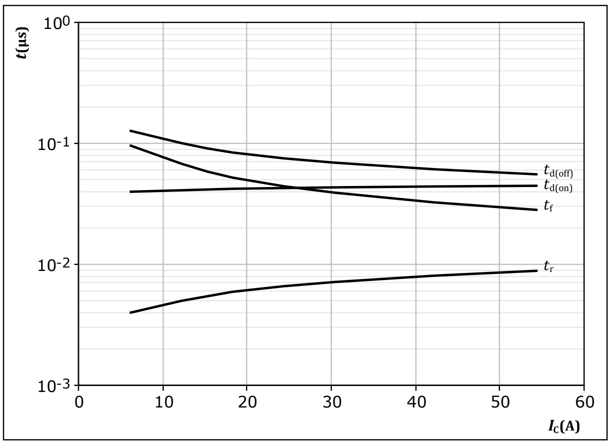
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

High Buck Switching Characteristics

figure 53. **IGBT**

Typical switching times as a function of collector current

t = f(I_C)



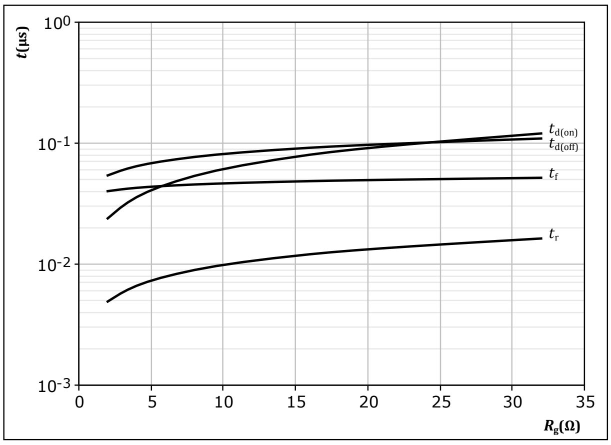
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	8	Ω
R_{goff} =	8	Ω

figure 54. **IGBT**

Typical switching times as a function of IGBT turn on gate resistor

t = f(R_g)



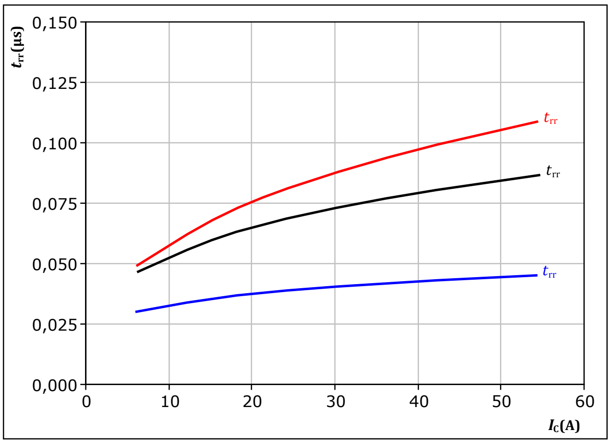
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	30	A

figure 55. **IGBT**

Typical reverse recovery time as a function of collector current

t_{rr} = f(I_C)



With an inductive load at

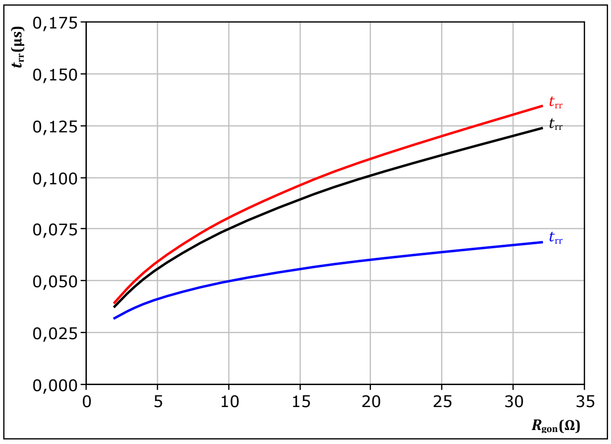
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	8	Ω

T_j: 25 °C / 125 °C / 150 °C

figure 56. **IGBT**

Typical reverse recovery time as a function of IGBT turn on gate resistor

t_{rr} = f(R_{gon})



With an inductive load at

V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	30	A

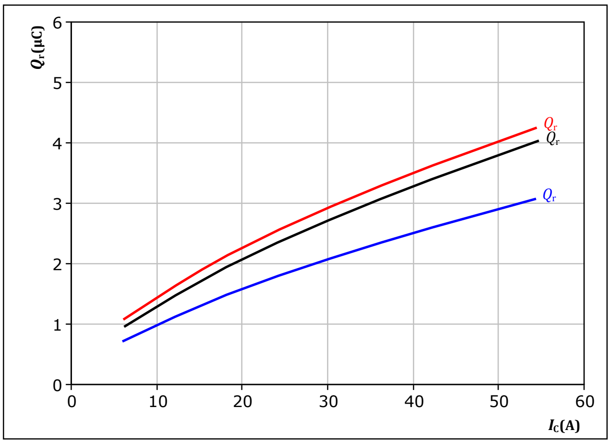
T_j: 25 °C / 125 °C / 150 °C

High Buck Switching Characteristics

figure 57. **IGBT**

Typical recovered charge as a function of collector current

Q_r = f(I_C)



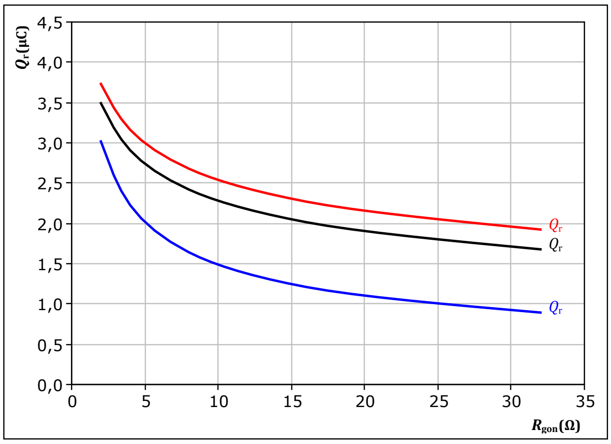
With an inductive load at

V_{CE} =	350	V	T_j: 25 °C / 125 °C / 150 °C
V_{GE} =	±15	V	
R_{gon} =	8	Ω	

figure 58. **IGBT**

Typical recovered charge as a function of IGBT turn on gate resistor

Q_r = f(R_{gon})



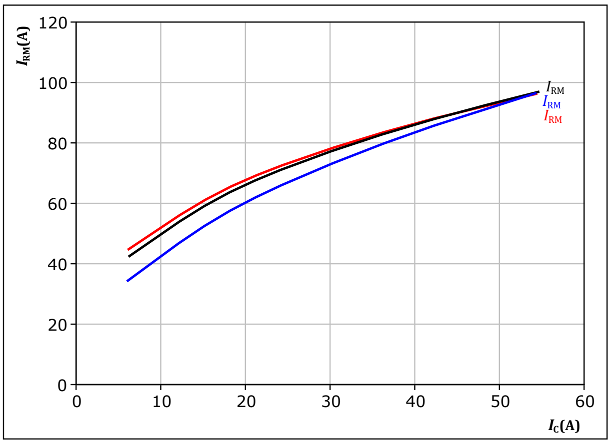
With an inductive load at

V_{CE} =	350	V	T_j: 25 °C / 125 °C / 150 °C
V_{GE} =	±15	V	
I_C =	30	A	

figure 59. **IGBT**

Typical peak reverse recovery current as a function of collector current

I_{RM} = f(I_C)



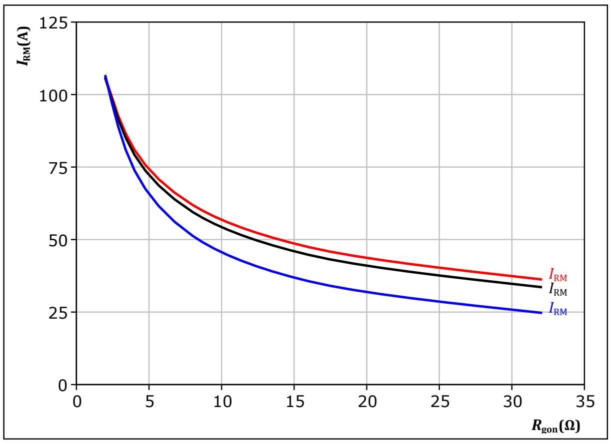
With an inductive load at

V_{CE} =	350	V	T_j: 25 °C / 125 °C / 150 °C
V_{GE} =	±15	V	
R_{gon} =	8	Ω	

figure 60. **IGBT**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

I_{RM} = f(R_{gon})



With an inductive load at

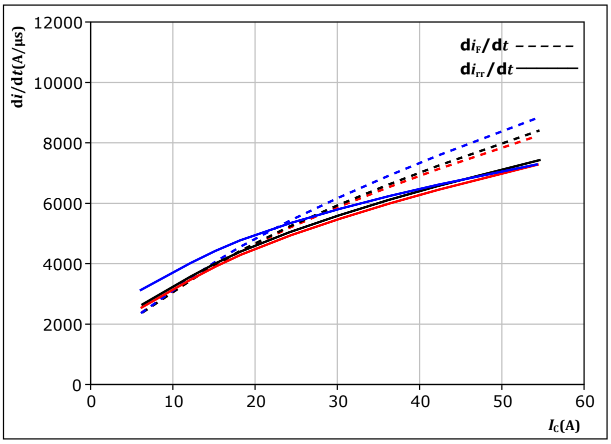
V_{CE} =	350	V	T_j: 25 °C / 125 °C / 150 °C
V_{GE} =	±15	V	
I_C =	30	A	

High Buck Switching Characteristics

figure 61. **IGBT**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



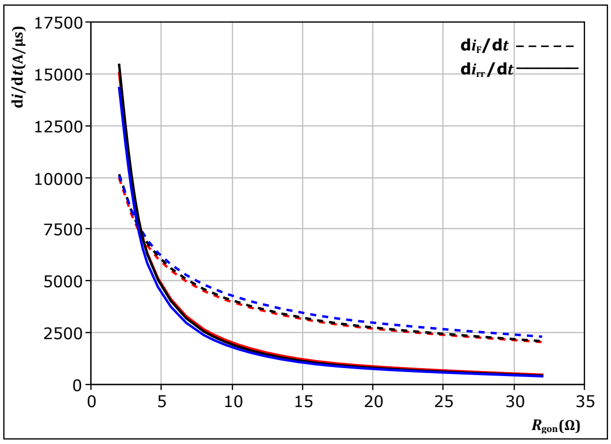
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 62. **IGBT**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



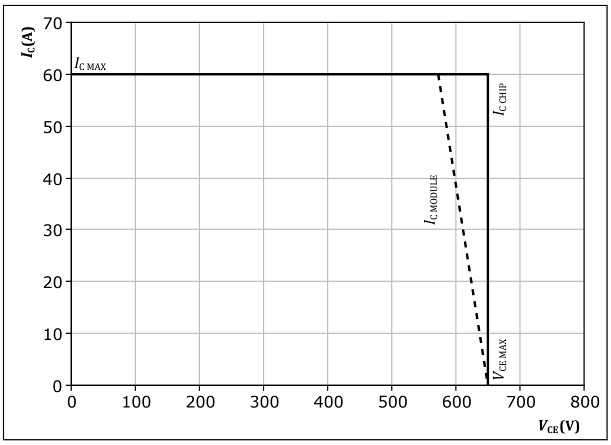
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	30	A		150 °C

figure 63. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



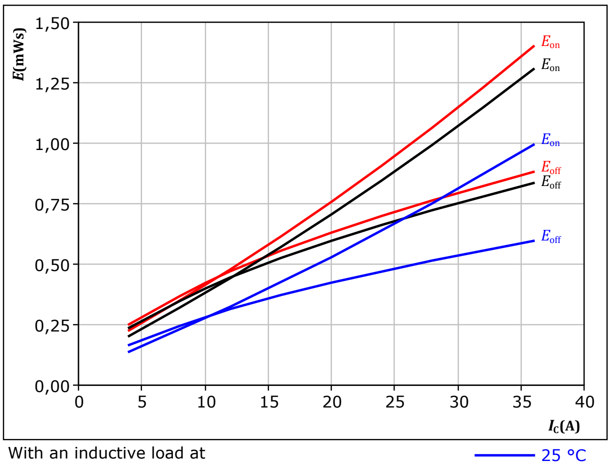
At	T_j =	150	°C
	R_{gon} =	8	Ω
	R_{goff} =	8	Ω

Boost Switching Characteristics

figure 64. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



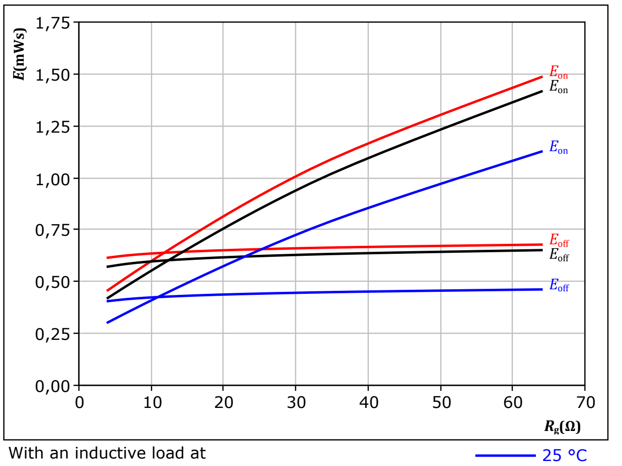
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	16	Ω		150 °C
R_{goff} =	16	Ω		

figure 65. **IGBT**

Typical switching energy losses as a function of IGBT turn on gate resistor

$E = f(R_g)$



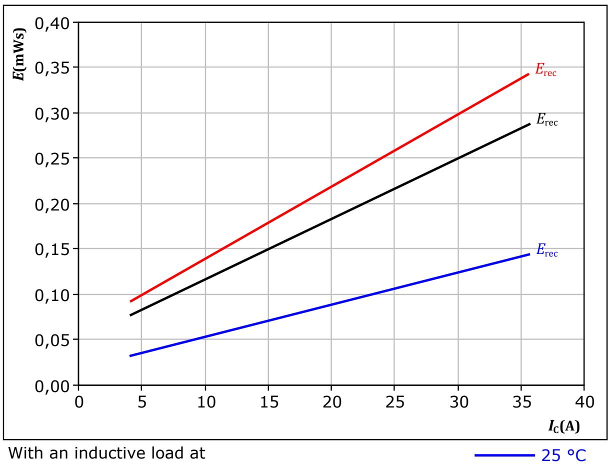
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	20	A		150 °C

figure 66. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



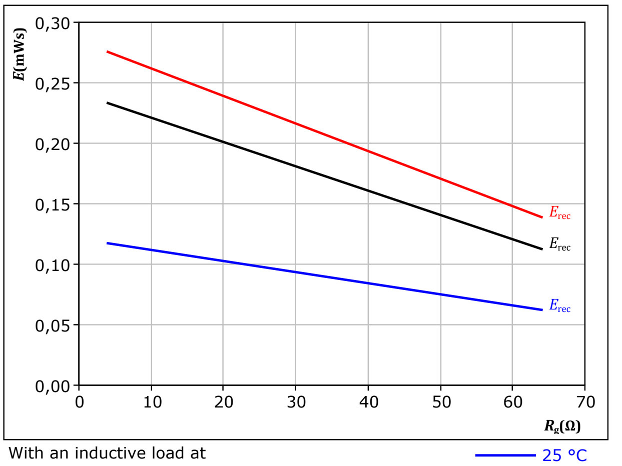
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	16	Ω		150 °C

figure 67. **FWD**

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

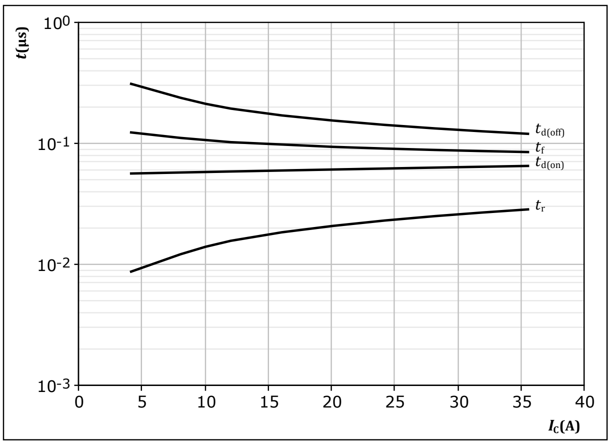
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	20	A		150 °C

Boost Switching Characteristics

figure 68. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



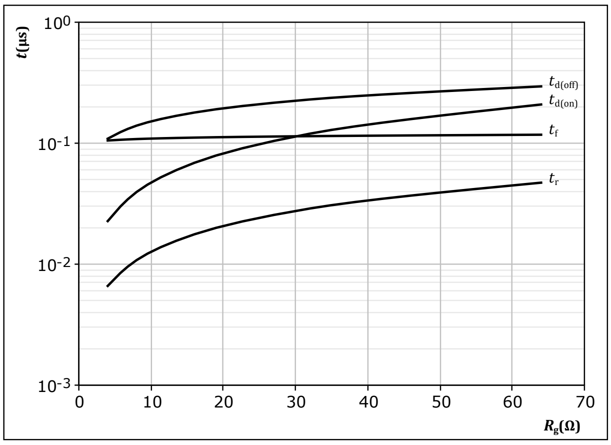
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	16	Ω
R_{goff} =	16	Ω

figure 69. **IGBT**

Typical switching times as a function of IGBT turn on gate resistor

$t = f(R_g)$



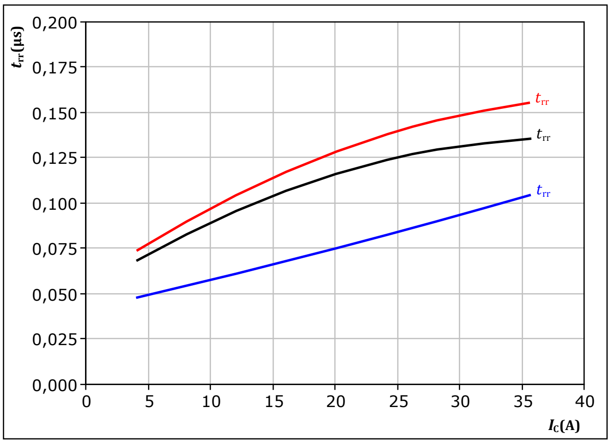
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	20	A

figure 70. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



With an inductive load at

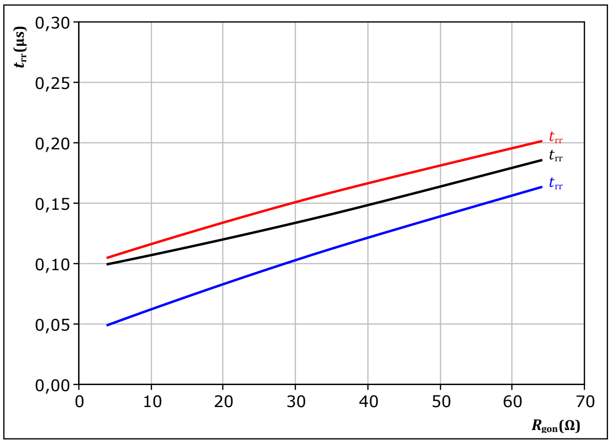
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	16	Ω

T_j: 25 °C, 125 °C, 150 °C

figure 71. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



With an inductive load at

V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	20	A

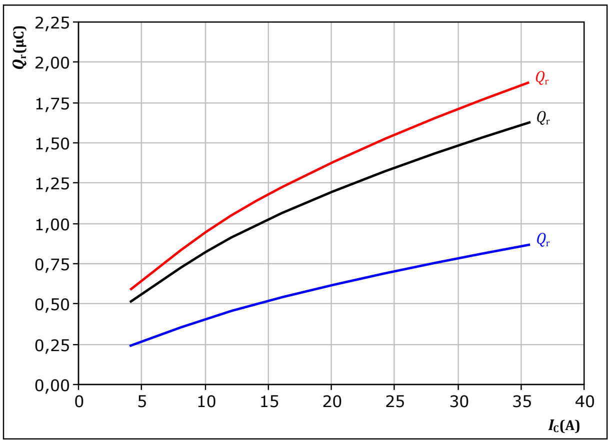
T_j: 25 °C, 125 °C, 150 °C

Boost Switching Characteristics

figure 72. **FWD**

Typical recovered charge as a function of collector current

Q_r = f(I_C)



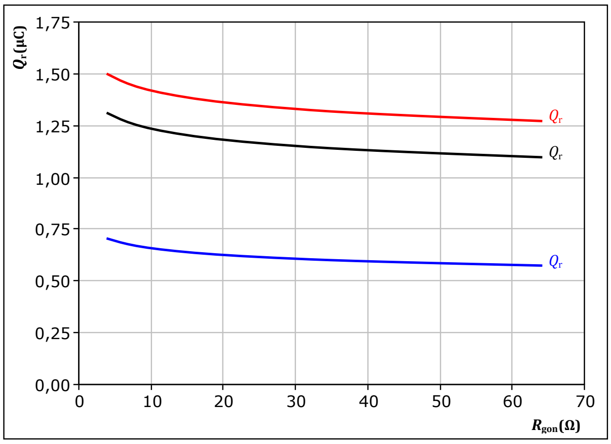
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	16	Ω		150 °C

figure 73. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

Q_r = f(R_{gon})



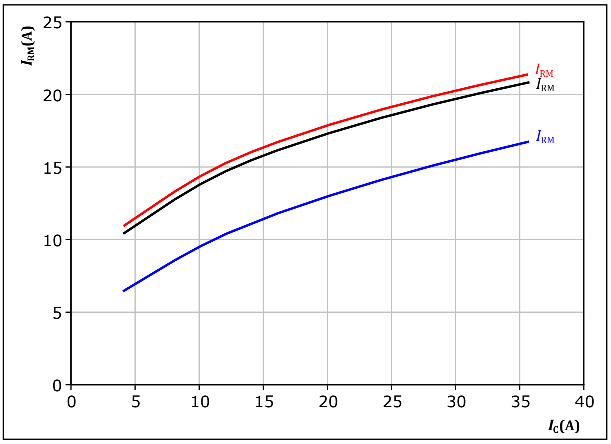
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	20	A		150 °C

figure 74. **FWD**

Typical peak reverse recovery current as a function of collector current

I_{RM} = f(I_C)



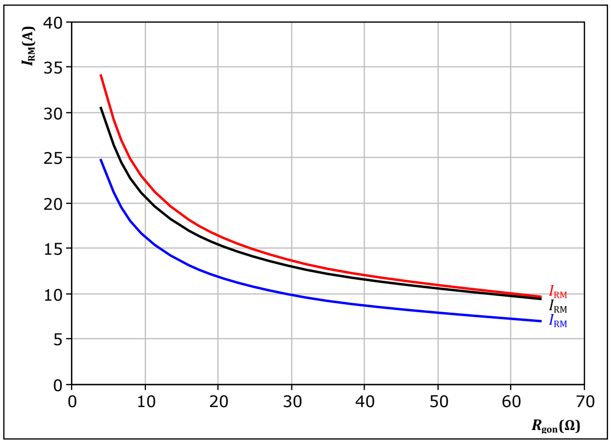
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	16	Ω		150 °C

figure 75. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

I_{RM} = f(R_{gon})



With an inductive load at

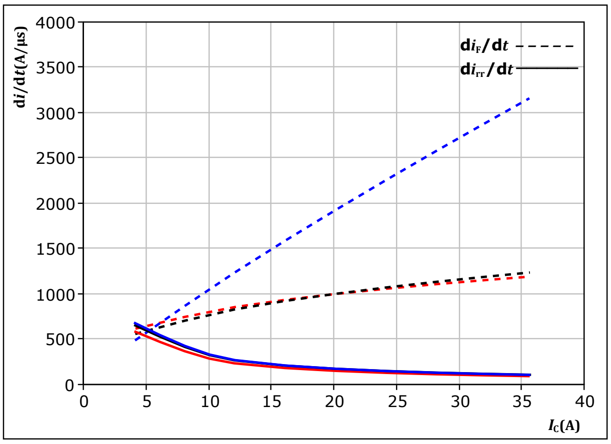
V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	20	A		150 °C

Boost Switching Characteristics

figure 76. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



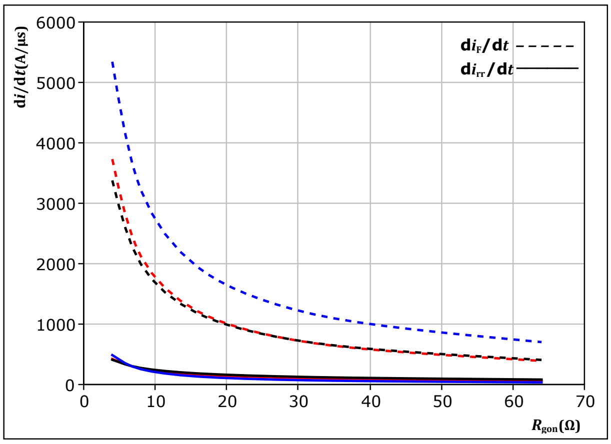
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	16	Ω		150 °C

figure 77. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



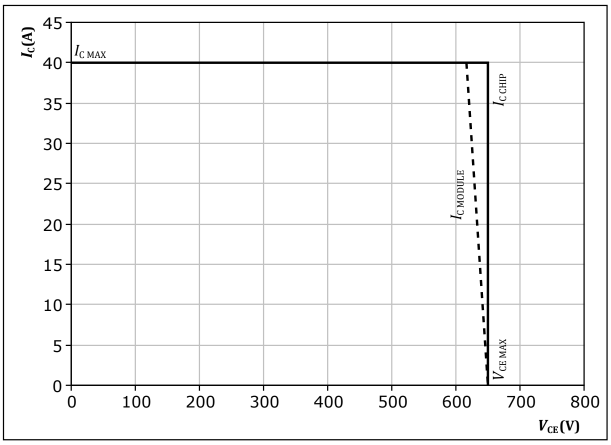
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	20	A		150 °C

figure 78. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



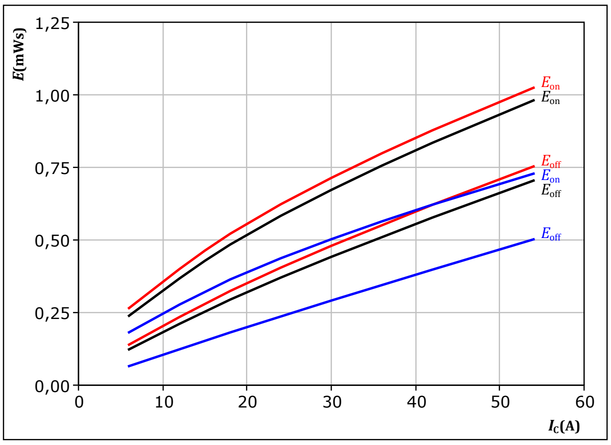
At	T_j =	150	°C
	R_{gon} =	16	Ω
	R_{goff} =	16	Ω

Input Boost Switching Characteristics

figure 79. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



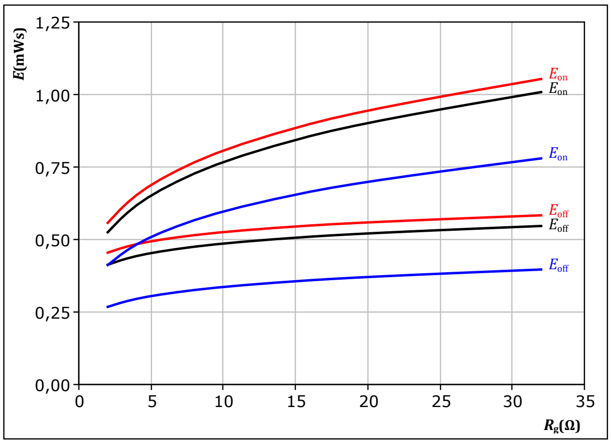
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
R_{gon} =	8	Ω		150 °C
R_{goff} =	8	Ω		

figure 80. **IGBT**

Typical switching energy losses as a function of IGBT turn on gate resistor

$E = f(R_g)$



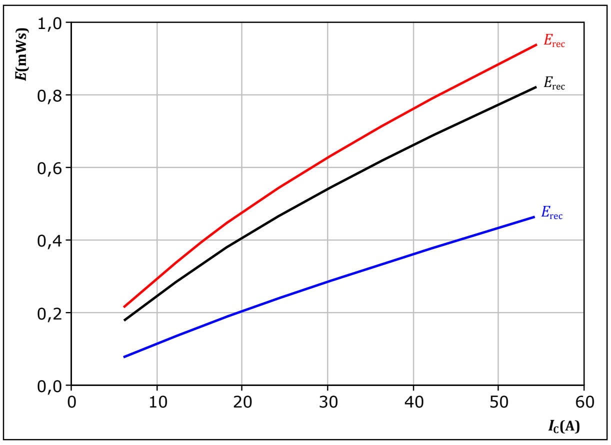
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
I_C =	30	A		150 °C

figure 81. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



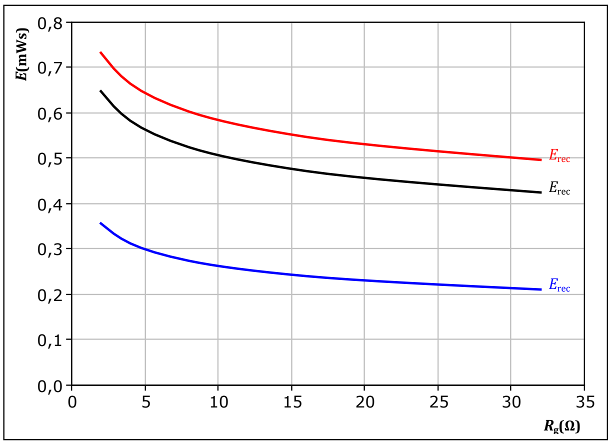
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 82. **FWD**

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

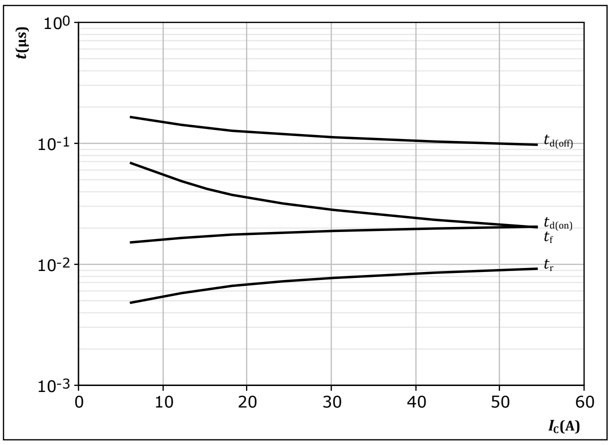
V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
I_C =	30	A		150 °C

Input Boost Switching Characteristics

figure 83. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



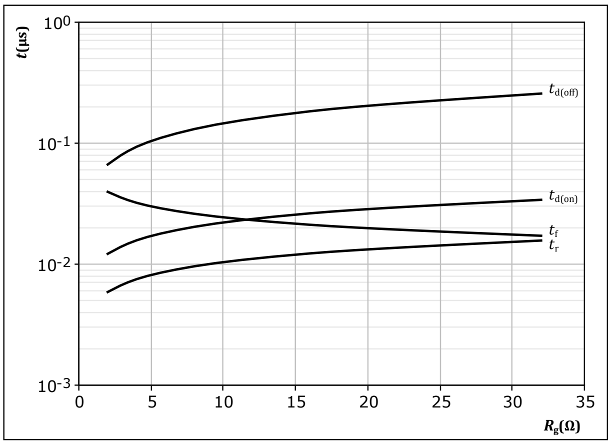
With an inductive load at

T_j =	150	°C
V_{CE} =	400	V
V_{GE} =	0/15	V
R_{gon} =	8	Ω
R_{goff} =	8	Ω

figure 84. **IGBT**

Typical switching times as a function of IGBT turn on gate resistor

$t = f(R_g)$



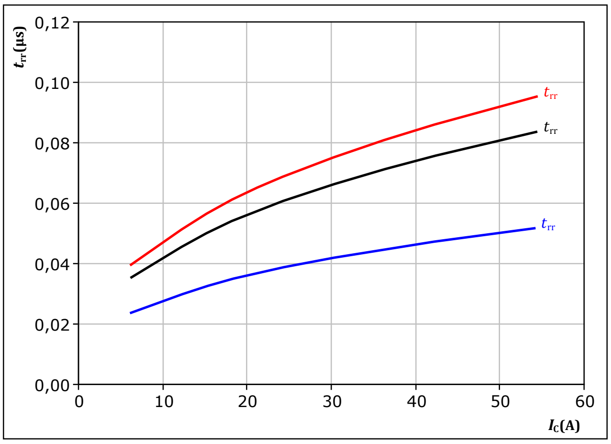
With an inductive load at

T_j =	150	°C
V_{CE} =	400	V
V_{GE} =	0/15	V
I_C =	30	A

figure 85. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



With an inductive load at

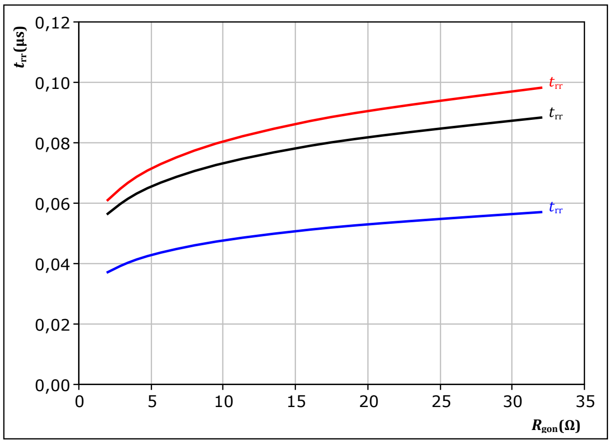
V_{CE} =	400	V
V_{GE} =	0/15	V
R_{gon} =	8	Ω

T_j: 25 °C, 125 °C, 150 °C

figure 86. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



With an inductive load at

V_{CE} =	400	V
V_{GE} =	0/15	V
I_C =	30	A

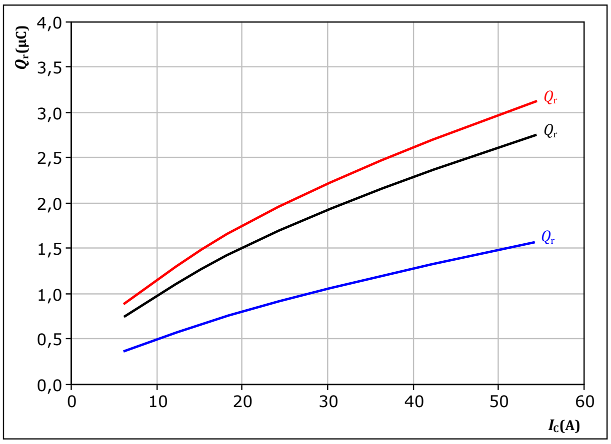
T_j: 25 °C, 125 °C, 150 °C

Input Boost Switching Characteristics

figure 87. FWD

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$



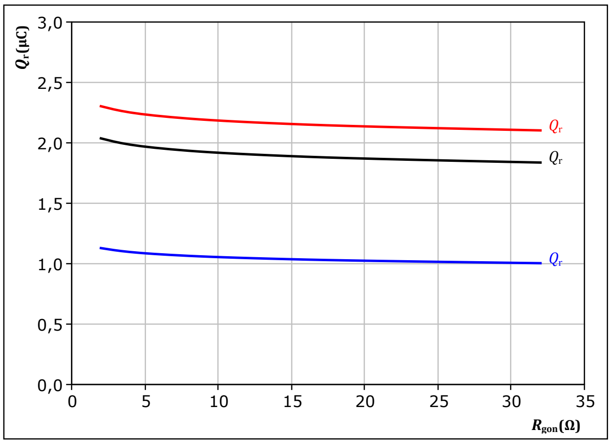
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 88. FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$



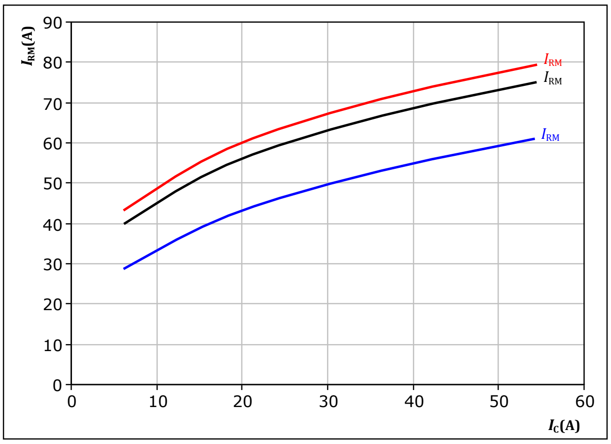
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
I_C =	30	A		150 °C

figure 89. FWD

Typical peak reverse recovery current as a function of collector current

$I_{RM} = f(I_C)$



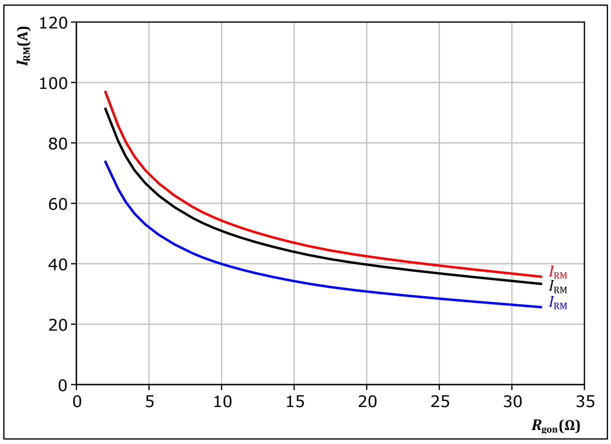
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 90. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



With an inductive load at

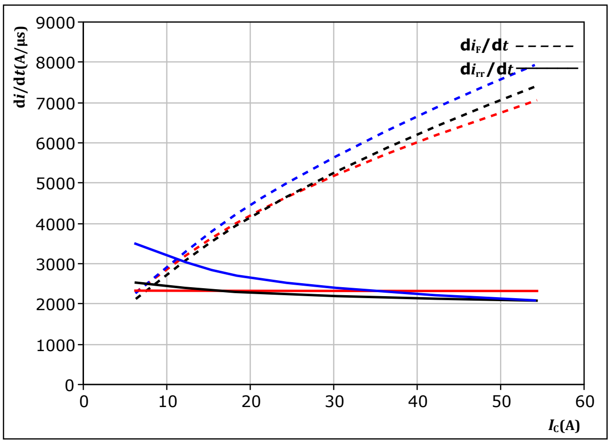
V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
I_C =	30	A		150 °C

Input Boost Switching Characteristics

figure 91. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, di_{rr}/dt = f(I_C)



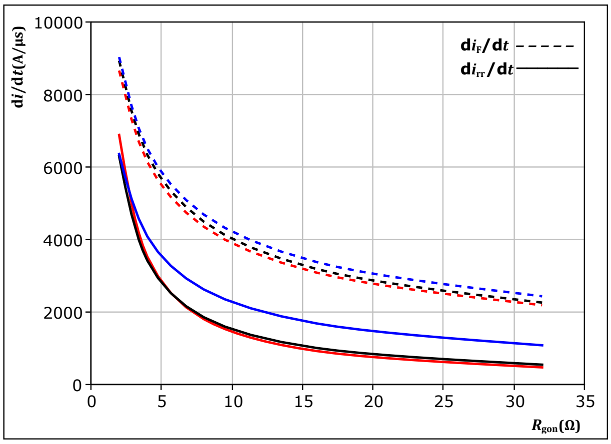
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
R_{gon} =	8	Ω		150 °C

figure 92. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor

di_F/dt, di_{rr}/dt = f(R_{gon})



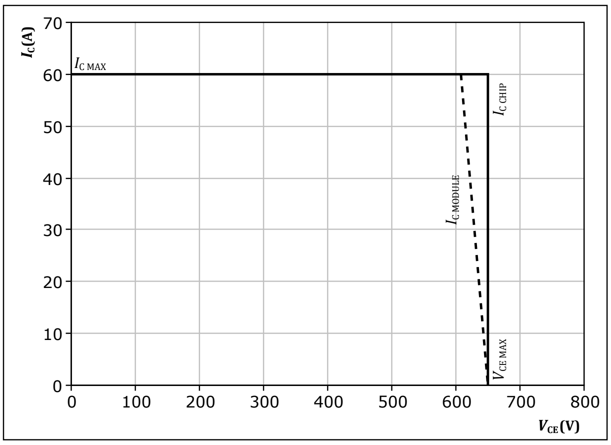
With an inductive load at

V_{CE} =	400	V	T_j:	25 °C
V_{GE} =	0/15	V		125 °C
I_C =	30	A		150 °C

figure 93. **IGBT**

Reverse bias safe operating area

I_C = f(V_{CE})



At	T_j =	150	°C
	R_{gon} =	8	Ω
	R_{goff} =	8	Ω

Switching Definitions

figure 94. **IGBT**

Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{tEoff} = integrating time for E_{off})

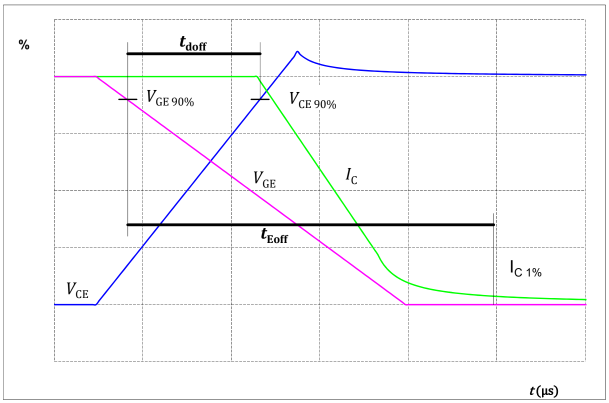


figure 95. **IGBT**

Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})

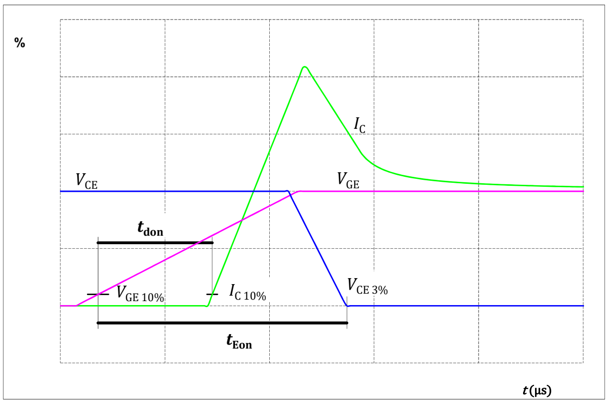


figure 96. **IGBT**

Turn-off Switching Waveforms & definition of t_f

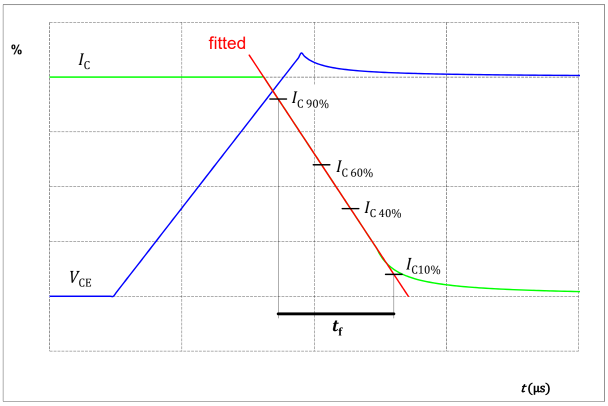
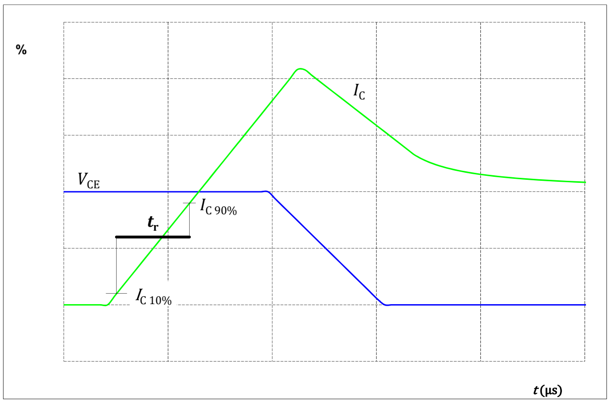


figure 97. **IGBT**

Turn-on Switching Waveforms & definition of t_r



Switching Definitions

figure 98. **FWD**

Turn-off Switching Waveforms & definition of t_{rr}

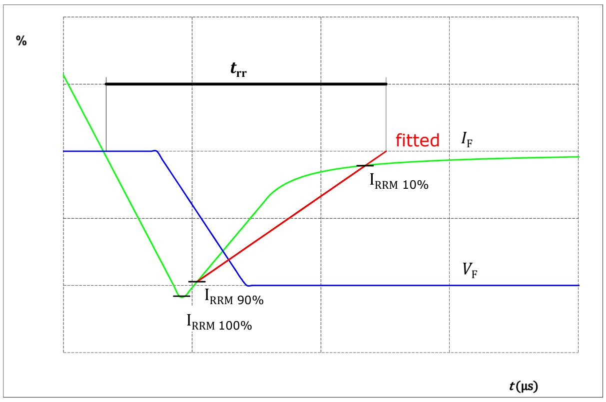
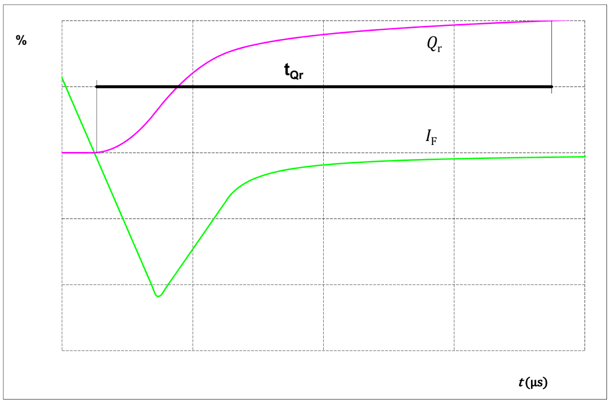


figure 99. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



Ordering Code

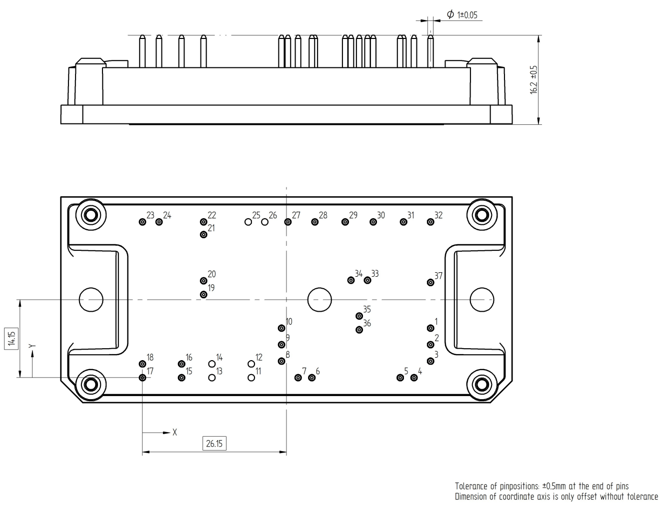
Version	Ordering Code
Without thermal paste	10-FY07BVA030RW-LF42E28
With thermal paste (5,2 W/mK, PTM6000HV)	10-FY07BVA030RW-LF42E28-/7/
With thermal paste (3,4 W/mK, PSX-P7)	10-FY07BVA030RW-LF42E28-/3/

Marking

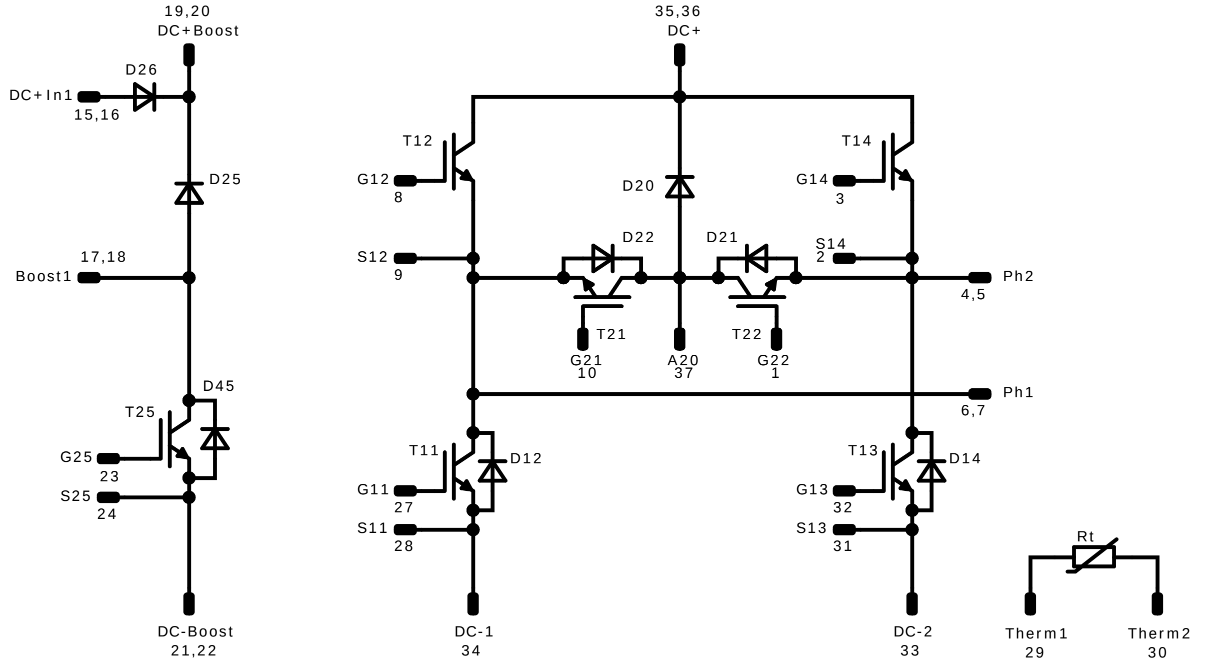
	Name		Date code	UL & VIN	Lot	Serial
Text	NN-NNNNNNNNNNNNNN-TTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
Datamatrix	Type&Ver	Lot number	Serial	Date code		
	TTTTTTTVV	LLLLL	SSSS	WWYY		

Outline

Pin table [mm]			
Pin	X	Y	Function
1	52,3	9	G22
2	52,3	6	S14
3	52,3	3	G14
4	49,3	0	Ph2
5	46,8	0	Ph2
6	30,75	0	Ph1
7	28,25	0	Ph1
8	25,25	3	G12
9	25,25	6	S12
10	25,25	9	G21
11	not assembled		
12	not assembled		
13	not assembled		
14	not assembled		
15	7,1	0	DC+In1
16	7,1	2,5	DC+In1
17	0	0	Boost1
18	0	2,5	Boost1
19	11,1	15,1	DC+Boost
20	11,1	17,6	DC+Boost
21	11,1	26	DC-Boost
22	11,1	28,3	DC-Boost
23	0	28,3	G25
24	3	28,3	S25
25	not assembled		
26	not assembled		
27	26,4	28,3	G11
28	31,3	28,3	S11
29	36,8	28,3	Therm1
30	41,9	28,3	Therm2
31	47,4	28,3	S13
32	52,3	28,3	G13
33	40,85	17,7	DC-2
34	37,85	17,7	DC-1
35	39,35	11,2	DC+
36	39,35	8,7	DC+
37	52,3	17,3	A20



Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11, T13	IGBT	650 V	30 A	Low Buck Switch	
T12, T14	IGBT	650 V	30 A	High Buck Switch	
D22, D21	FWD	650 V	20 A	Buck Diode	
T21, T22	IGBT	650 V	20 A	Boost Switch	
D14, D12	FWD	650 V	20 A	Low Boost Diode	
D20	FWD	650 V	20 A	High Boost Diode	
T25	IGBT	650 V	30 A	Input Boost Switch	
D25	FWD	650 V	30 A	Input Boost Diode	
D45	FWD	650 V	10 A	Input Boost Sw. Protection Diode	
D26	Rectifier	1600 V	35 A	ByPass Diode	
Rt	NTC			Thermistor	

Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 1 packages see vincotech.com website.

Package data
Package data for *flow* 1 packages see vincotech.com website.

Vincotech thermistor reference
See Vincotech thermistor reference table at vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
10-FY07BVA030RW-LF42E28-D3-14	1 May. 2022	New Datasheet format, module is unchanged	